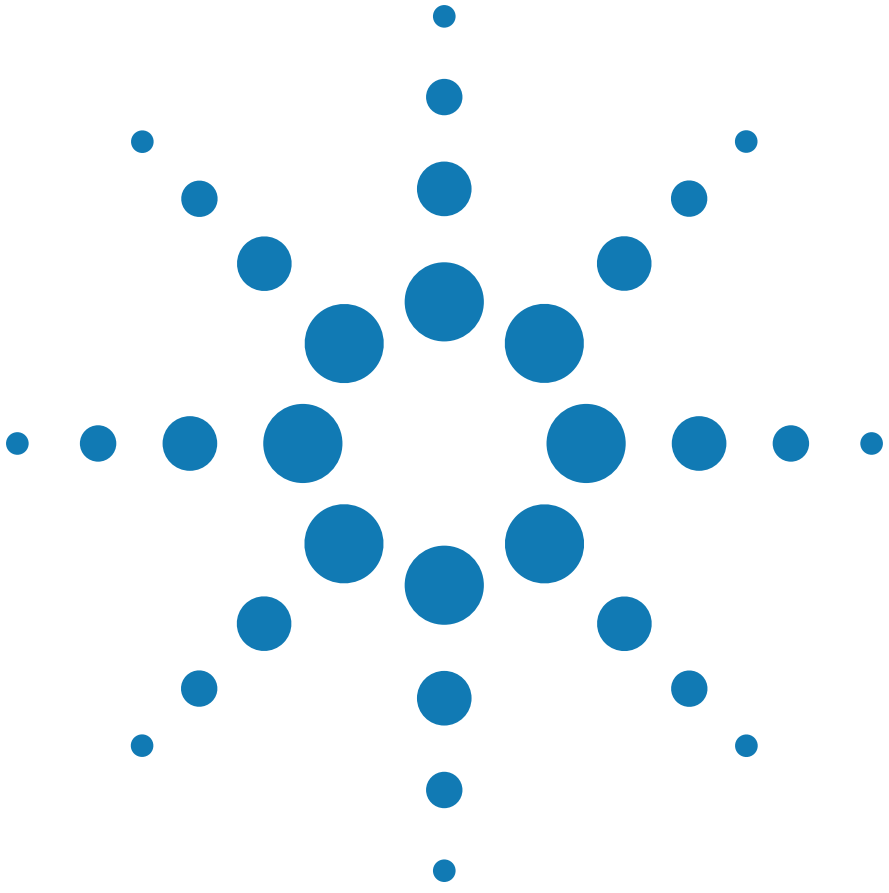
E1852A
Bluetooth™ Test Set



Operating Guide

Agilent Technologies

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	The Instruction Documentation Symbol. The product is marked with this symbol when it is necessary for the user to refer to the instructions in the supplied documentation.
	Alternating current (AC)
	This symbol indicates the operating switch for 'On' mode.
	This symbol indicates the position of the operating switch for 'Off' mode.
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WARNING A warning calls attention to a procedure, practice or the like, which, if not correctly performed or adhered to, could result in injury or loss of life. Do not proceed beyond a warning until the indicated conditions are fully understood and met.

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DO NOT defeat the earth-grounding protection by using an extension cable, power cable, or auto transformer without a protective ground connector. If you are using an auto transformer, make sure its common terminal is connected to the protective earth contact of the power source outlet socket.

DO NOT operate the product in an explosive atmosphere or in the presence of flammable gasses or fumes.

DO NOT use repaired fuses or short-circuited fuseholders: For continued protection against fire, replace the line fuse(s) only with fuse(s) of the same voltage and current rating and type.

DO NOT perform procedures involving cover or shield removal unless you are qualified to do so: Operating personnel must not remove equipment covers or shields. Procedures involving the removal of covers and shields are for use by service-trained personnel only.

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DO NOT substitute parts or modify equipment: Because of the danger of introducing additional hazards, do not install substitute parts or perform any unauthorized modification to the product. Return the product to an Agilent Sales and Service Office for service and repair to ensure the safety features are maintained.

Welcome

Welcome to the E1852A Bluetooth Test Set *Operating Guide*!

The E1852A Bluetooth Test Set provides a low-cost, stand-alone route to proving the performance of Bluetooth devices with measurements on both the transmit and receive paths.

Using the supplied Windows based user interface you can quickly perform critical RF measurements such as:

- initial carrier frequency error
- FM deviation
- peak and average power
- Bit Error Rate (BER)

Functional testing includes:

- establishing a link using standard Bluetooth protocol
- using page mode for 5-second link set up
- using a frequency hopping source and receiver with known performance

More detailed analysis and fault finding is possible using:

- frequency versus time
- power versus time
- power versus channel number

To help you develop your own applications, all the commands are logged when using the user interface in ‘debug’ mode. Using standard Windows’ tools, you can copy the commands and paste them into a program to quickly create an automated test sequence.

Documentation Information

This guide is only part of the information supplied. The documentation consists of:

- The *Installation Guide* - Shows you how to check your bluetooth test set, switch it on and connect it to the Device Under Test. The *Installation Guide* is supplied as a printed book and as an Adobe Acrobat PDF (Portable Document Format) file on the supplied CD-ROM.
- The *Operating Guide* - (this volume) - Shows you how to operate your bluetooth test set from the supplied User Interface for a PC or using the remote command set.

Conventions Used in this Guide

The following text conventions are used in this guide.

Run	used to represent the text in the Windows© based user interface
Parameter	used to represent a parameter, value or data in an entry field

Abbreviations Used in this Guide

The following abbreviations are used in this guide.

BD	Bluetooth enabled Device
EUT or DUT	Equipment or Device Under Test
NTP	Normally Transmitted Power or Average Burst Power
PTP	Peak Transmitted Power
BS	Bit Sequence

Specifications

Full specifications are listed in “Specifications and Characteristics” on page 131.

Contents

Introduction

Windows Interface

Making measurements

DLL Interfacing

Programming Reference

Specifications and Characteristics

Maintenance

1 Introduction

What You'll Find In This Chapter

This Chapter introduces you to the E1852A Bluetooth Test Set.

It contains these sections:

Introduction

The E1852A Bluetooth Test set supports a range of different tests as specified in the Bluetooth RF Test Specifications. It is a stand-alone piece of test equipment and can be used for high throughput manufacturing applications, and as a development or service tool.

For some test situations specified in the Bluetooth RF Test Specifications, additional test equipment, such as an ESA spectrum analyzer or ESG signal generator, can be used to compliment the E1852A bluetooth test set measurements. Consult the RF test specifications for further details.

The test set is basically a Bluetooth Host Controller with added test capabilities. Used as a test set it acts as the Bluetooth master and the Device Under Test (DUT) acts as the Bluetooth slave.

You can operate the test set using the supplied Windows based user interface or by sending SCPI format commands, either in the Windows environment or from within a test executive.

The operation of the DUT is controlled via the Air Interface. Using the standard test mode commands, you can set the DUT into test mode and carry out Transmitter and Loop back Tests.

Bluetooth RF components that are unable to establish a link can be tested using RF Analysis and RF Generator modes.

In addition to the RF IN/OUT port for connection with the DUT, several additional front and rear panel connections are provided. These are shown in the Installation Guide and in External Connections on page 13. With the Counter Input on the front panel, the test set can also be used as a frequency counter, measuring system frequencies of a Bluetooth device up to 15MHz.

External Connections

Rear Panel Connections

The E1852A Bluetooth Test Set provides rear panel input/outputs for the following functions:

External Reference	10 MHz timebase signal input
Slot Clock	A 1µs wide TTL trigger output at 0.5 times (625µs) Bluetooth frame rate
Receive Data	Inverted analogue output of the demodulated signal
Receive Slot Sync	A 1µs wide TTL trigger output synchronized with the start of a received burst
Power Envelope	Analog output of the RF power
Parallel Interface	25 pin male D-type connection for communication with a PC
Serial	9 pin female D-type for downloading firmware.
RS-232	RS-232 operation is not supported in this release

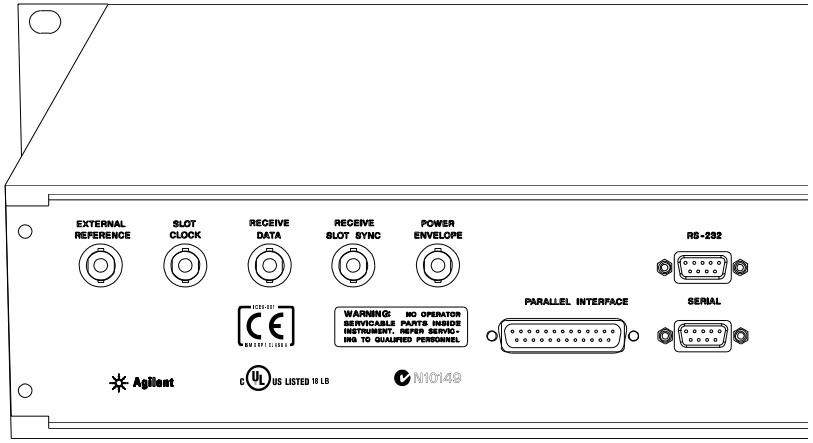


Figure 1 Rear Panel Connections

External Reference

10 MHz timebase signal input.

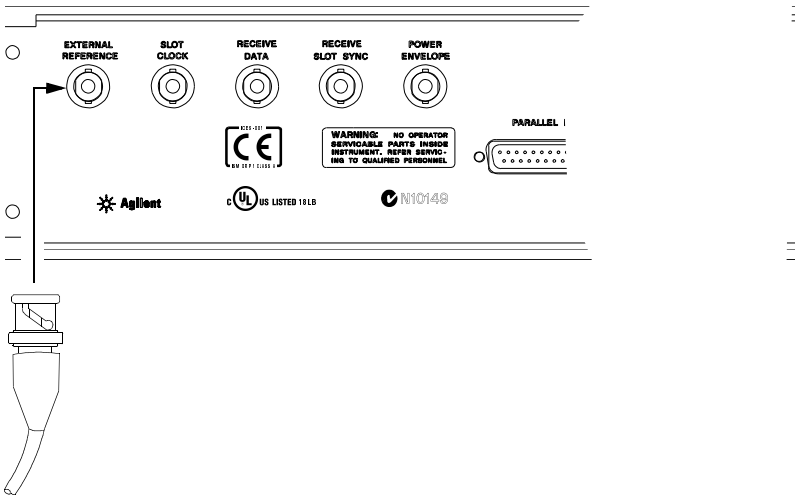


Figure 2 10 MHz Timebase Input

Slot Clock

1µs wide TTL level pulses at 2 times Bluetooth frame rate (625µs).

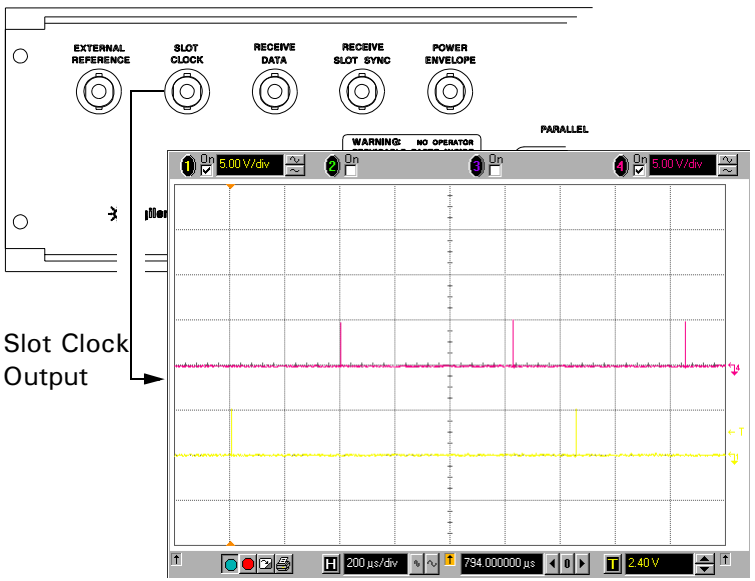


Figure 3 Slot Clock Output (with DH1 data)

Receive Data Inverted analogue output of the demodulated signal.

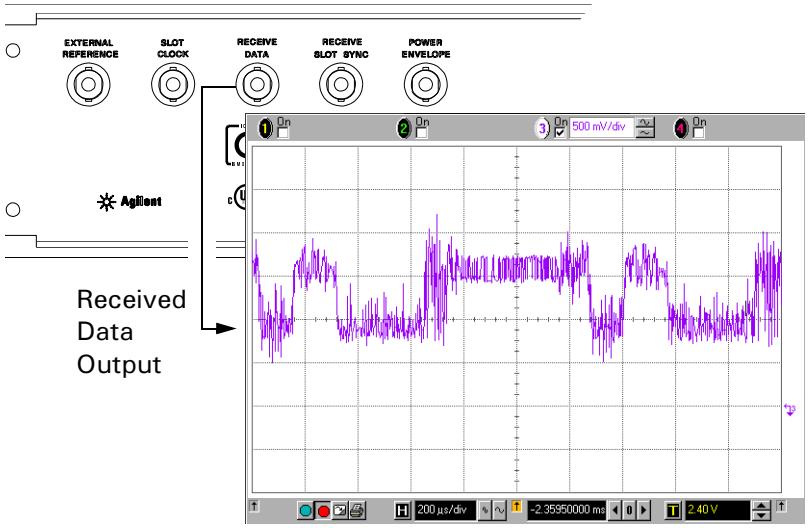


Figure 4 Receive Data Output

Receive Slot Sync A 1µs wide TTL trigger output synchronized with the start of a received burst.

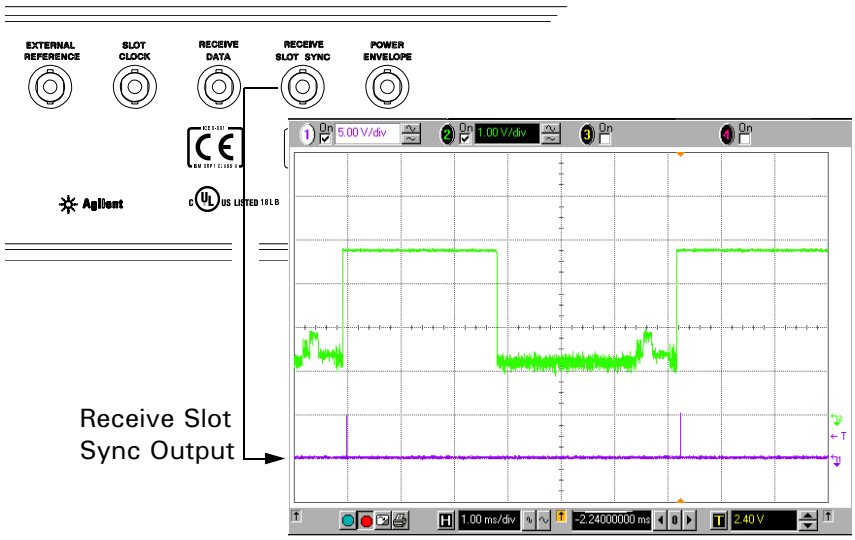


Figure 5 Receive Slot Sync Output

Power Envelope Analog output of the RF power.

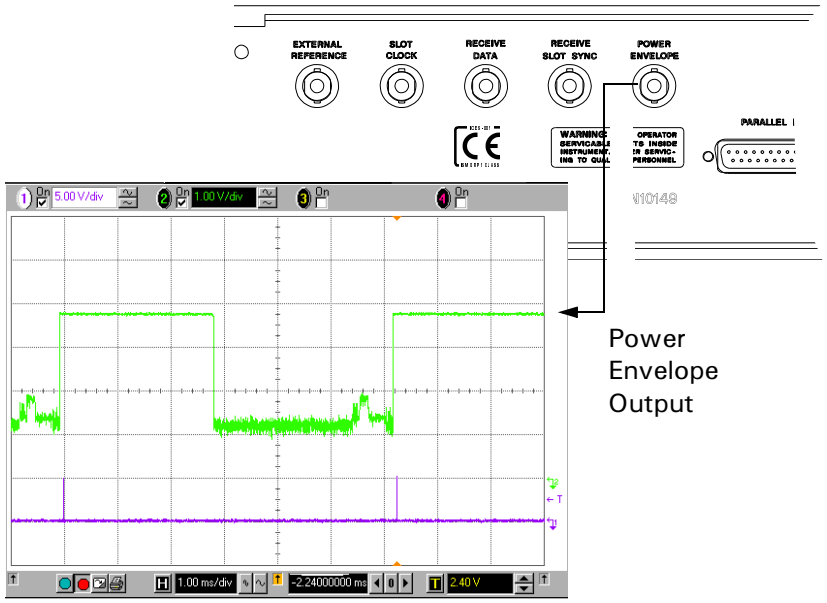


Figure 6 RF Power Envelope Output

Parallel Interface 25 pin male D-type connection for communication with your PC.

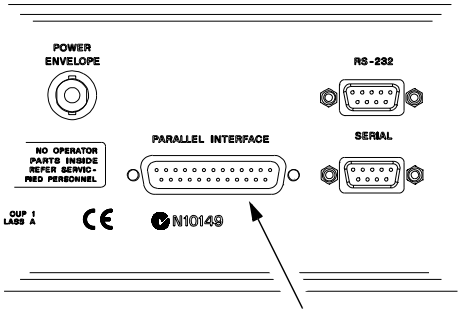


Figure 7 Parallel Interface

Serial 9 pin female D-type. The serial port is used for service purposes and to down-load new test set firmware. Use only the supplied cable for this purpose.

RS-232 The RS-232 interface is not supported in this release.

2 Windows Interface

What You'll Find In This Chapter

This chapter shows you the features of the Windows user interface.

It contains these sections:

Introduction

The E1852A Bluetooth Test Set can be controlled by the supplied Windows based user interface or by use of the SCPI compliant remote command set. The Windows user interface is intended for easy use in development and service situations. The user interface requires only a small amount of desktop space by using tab dividers to partition each major system mode. The program supports installation in Windows 95/98/2000 and Windows NT. Please refer to installation guide for further information.

You can start the user interface by double-clicking the desktop icon:

or by selecting **E1852A Bluetooth Tester** from the **Start, Programs** menu:

NOTE Selecting **E1852A Debug** starts a windows interface which includes an additional window showing the remote command dialogue between your computer and bluetooth test set. The dialogue can be captured in a log file and may be of use if you intend to develop your our control programs. Some additional frequency deviation measurements are also provided in debug mode.

Installation

If you have not already done so, install the Windows user interface and connect your PC by following the procedure detailed in “Install the User Interface” in the E1852A Bluetooth Test Set *Installation Guide*.

System Page

The **System** Page contains all the settings required for communication between a PC and the Test Set, and between the Test set and the DUT.

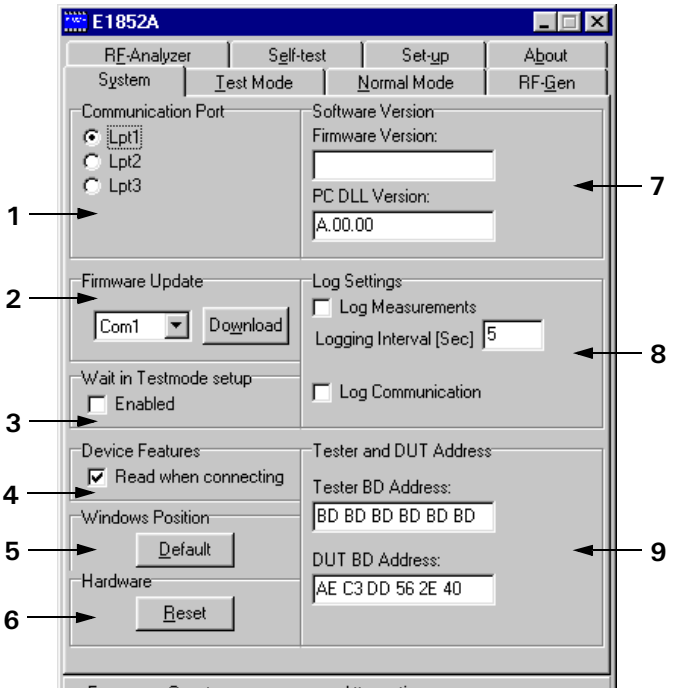


Figure 8 System Page (Debug Mode Shown)

System Page structure

The user interface always opens with the **System** page displayed. It contains the following panels:

1. Communication Port

The radio buttons on the **Communication Port** panel are used to select the PC port you want to use for control of the test set.

2. Firmware Update (Debug Mode Only)

The Firmware Update panel is used to set the required communication port and initiate the firmware download process. This is only available in debug mode and you should refer to the instructions on the E1852A Software Home Page. (The URL can be found on the **About** page of the user interface.)

3. Wait in Testmode Setup

This command sets the test set to wait in test mode before sending the test activate message to the DUT. This is required by some DUTs. It does not apply to a normal mode connection

4. Device Features

When enabled, the test set polls the DUT on connection and displays the DUT Bluetooth features.

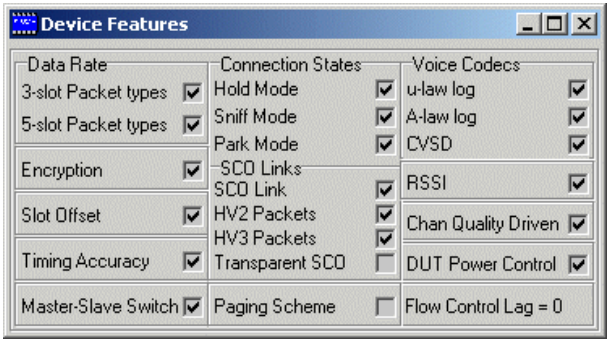


Figure 9 DUT Features (sample)

5. Windows position

Clicking **Default** places the user interface window in the upper left corner of your PC display.

6. Hardware

Click **Reset** to initialize the test set. All prior test set configurations are retained.

7. Software Version

When the test set is started and the user interface program is launched, the test set returns information about the firmware version and the PC Dynamic Link Library (DLL) file.

NOTE The user interface software and the test set software must be the same version. If they differ an error message is displayed. Refer to Firmware Download on page 143.

8. Log Settings

The user interface can be configured to store measurement information from the test set at set intervals. The default interval is 5 seconds and can be changed by entering the interval in the **Logging Interval (Sec.)** Field.

Clicking the **Log Measurements** check box opens a dialog box where you can choose the filename and path.

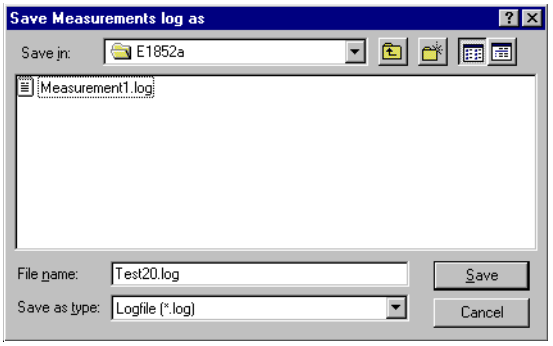


Figure 10 Save Measurement Log

The saved file contains measurements regarding the specific Bluetooth measurement. For example, in loop back measurements, with a 5 second interval, the BER values are logged into the file as shown in Figure 11. This type of text-only file can easily be imported into a spreadsheet for analysis.

NTP, or Normally Transmitted Power, is the average power whereas PTP, Peak Transmitted Power, is the peak power measured.

```
09:58:58;  TestMode
09:58:58;  NTP;      PTP;      FrqOff;   FrqDft;   FrqDev;   dAvg;     dMax;
09:59:00;  20.51;    21.00;    4.4;      ---;      ---;      ---;      ---;
09:59:05;  20.56;    21.60;    -30.2;    ---;      ---;      ---;      ---;
09:59:10;  -14.17;   -40.40;   -38.2;    ---;      ---;      ---;      ---;
09:59:15;  0.63;     -40.30;   -20.6;    ---;      ---;      ---;      ---;
09:59:20;  6.84;     -41.30;   55.4;     ---;      ---;      ---;      ---;
09:59:25;  -13.69;   -39.40;   -3.1;     ---;      ---;      ---;      ---;
09:59:30;  -13.51;   -39.90;   68.7;     ---;      ---;      ---;      ---;
09:59:35:  -12.60:   -43.00:   25.5:     ---:      ---:      ---:      ---:
```

```
dMin;   BER;          PER
---;    81000 0 0.000000;      376 0 0.000000;
---;    512784 0 0.000000;     2376 0 0.000000;
---;    668736 1193 0.178396;  4380 1262 28.812786;
---;    7128 845 11.854658;    6383 3213 50.336834;
---;    14256 1737 12.184343;  8385 5161 61.550388;
---;    22032 2669 12.114198;  10388 7114 68.482864;
---;    29808 3545 11.892780;  12404 9080 73.202194;
---:    37584 4516 12.015752:  14408 11038 76.610214:
```

Figure 11 Log File Content

NOTE You can use **Log Communication** (only available in in Debug mode) to capture all of the data traffic, including the commands.

9. Tester and DUT address

The 12 digit hexadecimal (hex) BD address of the test set is displayed in the **Tester BD Address:** field. You can choose a new address and save it in the test set memory by entering the new address in the **Tester BD Address:** field and pressing **Reset**. This address may require changing for specific module application programs.

To enable communication between the test set and the DUT, the unique DUT BD address must be entered in the **DUT BD Address:** field.

Table 1 System Page - Panel Summary

	Panel	Parameters	Description
1.	Communication Port	Lpt1 Lpt2 Lpt3	PC parallel ports for control of the test set. Lpt1 is default
2.	Firmware Update	Com1 to Com 9	Used to download new firmware to the test set
3.	Wait in Testmode Setup	Enabled/Disabled	The test set pauses during a testmode setup as required by some DUTs
4.	Device Features	Readback enabled/disabled	Displays the DUT enabled Bluetooth features
5.	Windows Position	Default	Pressing Default places the user interface in the top left corner of your PC desktop
6.	Hardware	Reset	Pressing Reset initiates a 'warm start' reset of the test set
7.	Software Version	Firmware Version	The test set is polled and the Firmware version is displayed
		PC DLL Version	Displays the DLL version held on the PC
8.	Log Settings	Log Measurement	Log file containing all the measurements
		Log Interval (sec.)	Length of time between data logging events in seconds
		Log Communication	Log file containing all the measurements and commands
9.	Tester and DUT address	Tester BD Address	Entry and display of the BD address of the test set
		DUT BD Address	Entry and display of the BD address of the DUT

Frequency Counter and Attenuation

Two additional panels are always displayed below the currently selected page. The **Frequency Counter** and **Attenuation** panels are visible at all times.

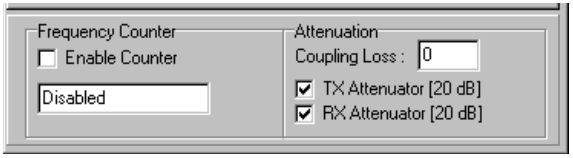


Figure 12 Frequency Counter and Attenuation Panels

Frequency Counter

Clicking the **Enable Counter** check box enables the counter. The frequency of the signal present at the **COUNTER IN** BNC connector on the test set front panel is measured and displayed. (The input parameters are described in "General Specifications" on page 137.)

Attenuation

If the coupling loss at the RF IN/OUT connector is known, the value can be entered in the **Coupling Loss:** field. The test set factors the loss into the measurement results.

Clicking the box for **TX Attenuator** adds 20 dB attenuation in the transmit direction from the test set to the DUT. Similarly, clicking the **RX Attenuator** box adds 20 dB attenuation in the test set receive direction.

When no transmit attenuator is selected, the RF level at the test set output can vary from –35 dBm to –75 dBm.

NOTE Do not connect a signal to the front panel during a measurement

Communication Window (Debug Only)

The Communication window is only displayed when you start the user interface in debug mode (**Start**, **Programs**, **Agilent Technologies**, **E1852A Debug**).

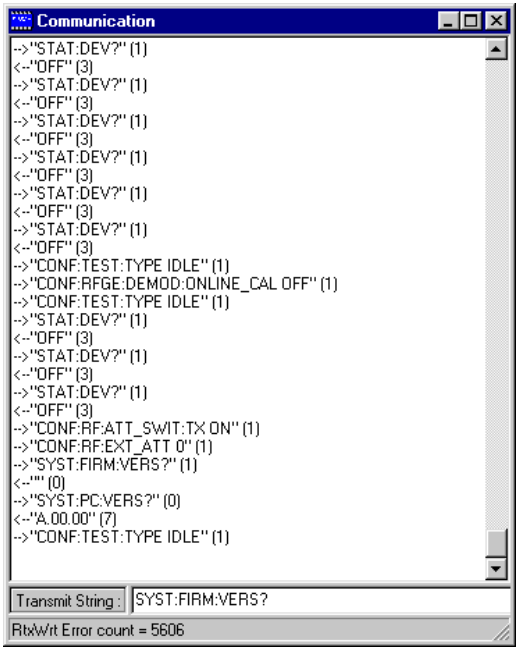


Figure 13 Communication Window

You can use this window to view and record the communication between your PC and test set, and send one command at a time in the **Transmit String** line. For more information about this feature refer to “Command Structure” on page 124.

Test Mode Page

The **Test Mode** Page contains the settings required for making measurements in Bluetooth Test Mode[1].

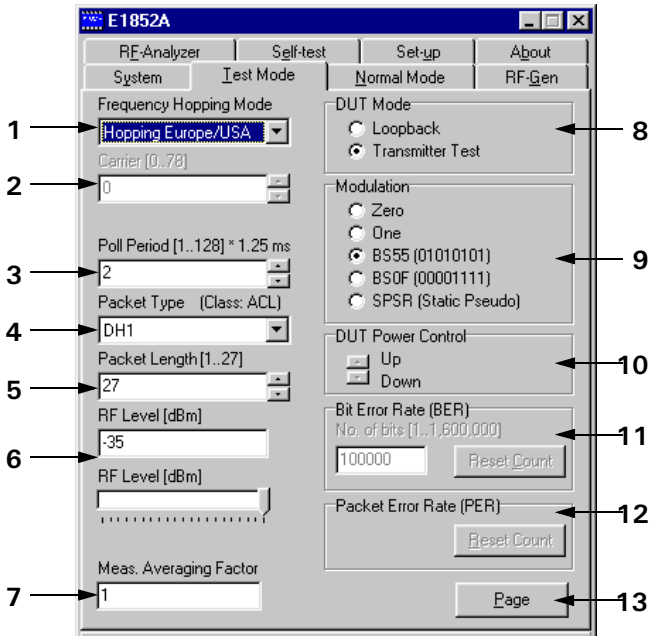


Figure 14 Test Mode Page

Test Mode Page structure

The **Test Mode** page contains the following panels and entry fields:

1. Frequency Hop Mode

In **Test Mode**, you can choose to make measurements on a specific channel or in Bluetooth frequency hopping mode. Use this selection field to select Single Frequency or Hopping Europe/USA.

[1] There are variations in Bluetooth Test Mode between suppliers. Contact your Agilent support if you have questions or experience problems

2. Carrier

The **Carrier** entry field is only enabled if you have chosen to make measurements in a single channel. You can select any one of the 79 channels on the ISM band (channel 0 – 78 ~ 2.402 – 2.480 GHz).

Channel 40 is the mid frequency at 2.442 GHz.

3. Poll Period

The time period for transmitting Bluetooth test packets in Transmitter or loop back mode.

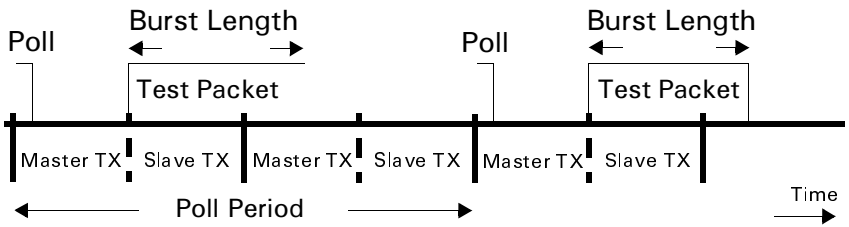


Figure 15 Transmitter Test Mode

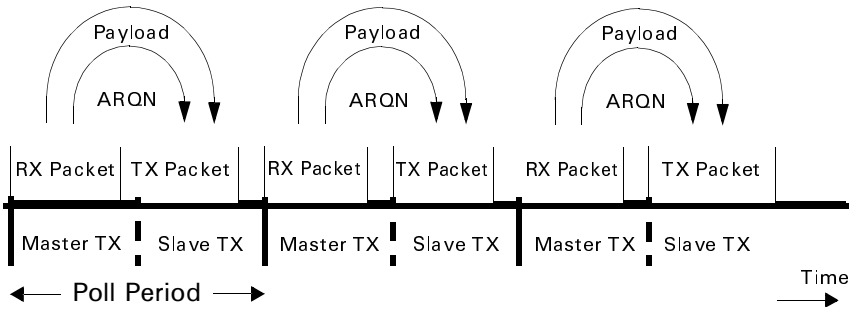


Figure 16 Loopback Test Mode

4. Packet Types

You can select a Bluetooth specific single or multi slot packet. The supported packet types are **DH1** to **DH5**, **HV3**, and **AUX1**. DH (Data High Rate) packets are asynchronous whereas HV (Human Voice) packets are synchronous. Most Bluetooth tests use the DH packets as no error correction is applied to these packets thus the fundamental RF performance is more visible.

5. Packet length

The length of the packets can be adjusted from **1** to **27** for **DH1** single slot packets, **1** to **183** for **DH3** multi slot packets and **1** to **339** for **DH5** packets.

6. RF Level

The RF power level in the test set transmit direction can be adjusted for sensitivity measurements.

The power levels, with attenuation, can be adjusted from –55 to –95 dBm, and without attenuation from –35 to –75 dBm.

The power level can be entered directly in the **RF Level [dBm]** field or adjusted by moving the **RF Level** slider.

7. Meas. Averaging Factor

You can choose to make measurements on single packets or average the results over a number of packets up to a maximum of 999. A lower number updates the measurement more frequently. The default setting of 1 is often the optimum value.

8. DUT Mode

In this panel you can choose **Loopback** or **Transmitter Test**. Choosing **Loopback** mode enables **Packet Error Rate (PER)** and **Bit Error Rate (BER)** measurements.

Various modulation patterns (**Modulation** panel) are available when **Transmitter Test** mode is selected. In this mode the test set instructs the DUT to transmit the specified patterns.

NOTE Not all devices support this function.

9. Modulation

When **Transmitter Test** is the selected **DUT Mode**, 5 modulation patterns are available (**Zero**, **One**, **BS55**, **BS0F**,and **SPSR**). For example, BS55 specifies a 0101 0101 bit pattern. The modulation patterns are shown in Figure 17, Figure 18, Figure 19, Figure 20, and Figure 21.

The static pseudo random modulation (PN9) is the only pattern used when the **DUT Mode** is set to **Loopback**.

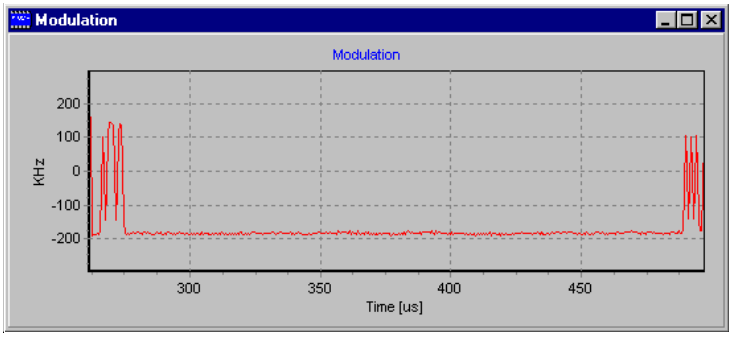


Figure 17 Modulation Pattern 'Zero'

NOTE All '0' or all '1' payloads can be useful for checking for interference on the DUT transmission. Specific radio types may not function correctly or support these payloads.

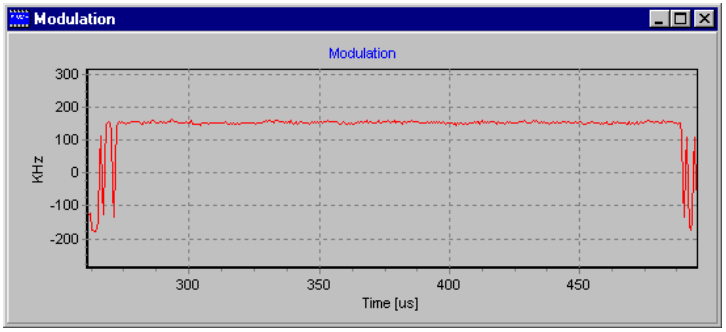


Figure 18 Modulation Pattern 'One'

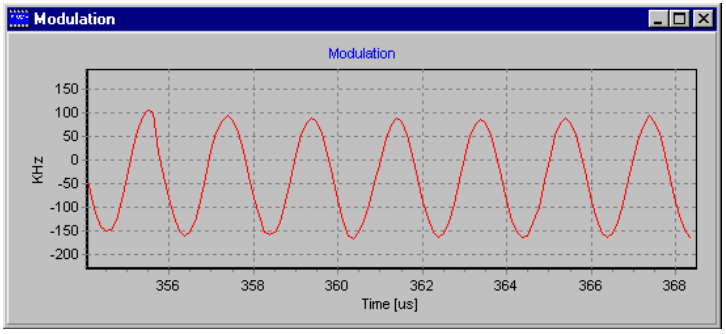


Figure 19 Modulation Pattern 'BS55 (01010101)'

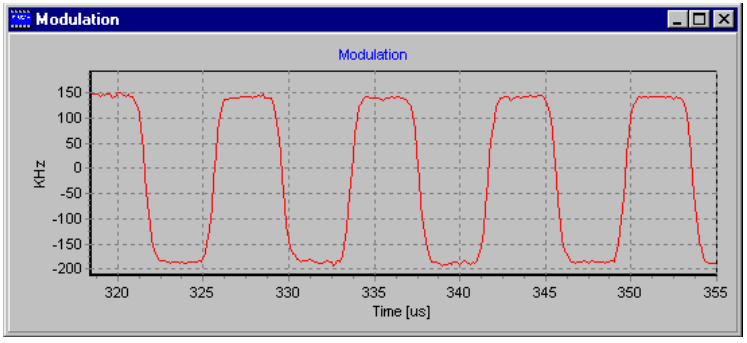


Figure 20 Modulation Pattern 'BS0F (00001111)'

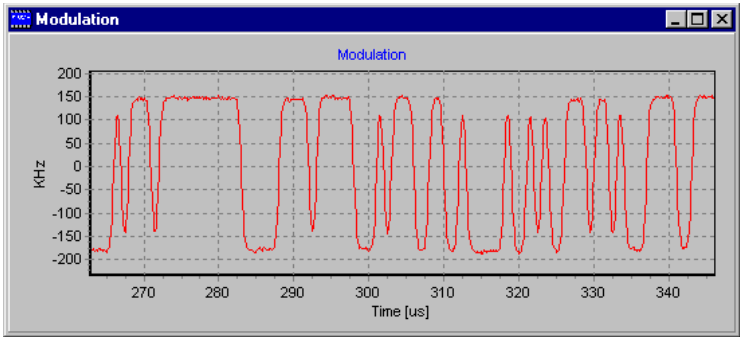


Figure 21 Modulation Pattern 'SPSR (Static Pseudo)'

10. DUT Power Control

If the DUT supports this feature, you can use the up/down buttons to control its RF output level.

11. Bit Error Rate (BER)

You can enter the number of bits to be used in measuring the **Bit Error Rate** in the entry field. The valid range is 1 to 1,600,000 bits.

The Bit Error Rate can be seen to change rapidly with small changes in RF level. A change from 0.01% to over 1% is possible due to a 5dB level change.

12. Packet Error Rate (PER)

You can enter the number of Bluetooth packets to be used in measuring the **Packet Error Rate** in the entry field.

The valid range is 1 to 65000 packets.

13. Page/Release

Clicking **Page/Release** opens or closes a Bluetooth RF connection between the test set and the DUT. Clicking **Page** opens a **Measurements** window. When a Bluetooth connection is established, the 'Measurements' window is displayed. Also the **Page** button changes to **Release**. Clicking **Release** closes the connection.

NOTE Closing the **Measurements** window also releases the connection to the DUT

Table 2 Test Mode Page - Panel Summary

	Panel	Parameters	Description
1.	Frequency Hop Mode	Single Frequency or Hopping Europe/ USA	Selects Frequency Hopping on or off
2.	Carrier	0 to 78	Entry and display of the ISM band channel number (0 to 78, 2.402 to 2.480 GHz)
3.	Poll Period	1 to 255	Selects the time period for transmitting test packets - depends on packet type
4.	Packet Types	DH1 to DH5, HV3 and AUX1	Selects the data packet type
5.	Packet Length	1-27 for DH1 1-183 for DH3 1-339 for DH5	Selects the packet length
6.	RF Level	-55 to -95 dBm with attenuation -35 to -75 dBm without atten.	Entry field or slider to control the RF level
7.	Meas. Averaging Factor	1 to 999	Selects the number of packets to be used for the measurement
8.	DUT Mode	Loopback or Transmitter Test	Selects the test mode required for the DUT - Loopback enables PER and BER measurements, various modulation patterns can be used with Transmitter Test
9.	Modulation	Zero, One, BS55, BS0F, SPSR	Selects the modulation required for the Transmitter Tests
10.	DUT Power Control	variable	Enables adjustment of DUT RF level (if supported by DUT)
11.	BER	1 to 1,600,000	Selects the required bits for the BER measurement (Loopback test)

	Panel	Parameters	Description
12.	PER	1 to 65000	Selects the required packets for the PER measurement (Loopback test)
13.	Page/Release		Opens and closes the Bluetooth connection to the DUT

Measurements Window

When a Bluetooth connection is established, the **Measurements** window is displayed. The measurement results are continuously updated and shown in the display fields of this window. Associated with each result is a red/green bar with a small indicator in black which are described in detail in the section Set-up Page on page 52.

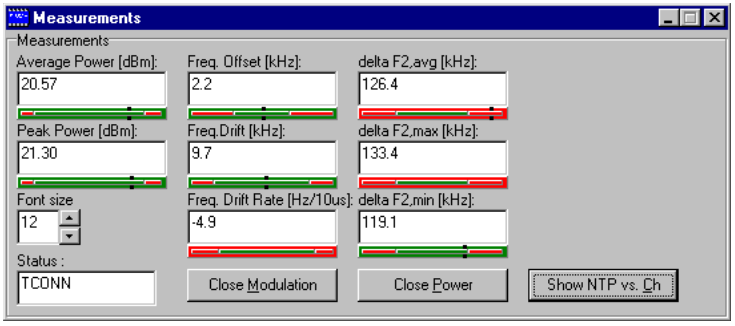


Figure 22 Transmitter Test Measurements Window

RF measurement parameters in Transmitter Test DUT Mode

The following parameters are displayed in the **Measurements** window during **Transmitter Test**:

- **Average Power**
- **Peak Power**
- **Frequency Offset**
- **Frequency Drift** - 0101 pattern only

- **Frequency drift Rate** - 0101 pattern only
- **Delta F2 Average** - Delta F1 average with 00001111 pattern
- **Delta F2 Max** - using Debug version of user interface only
- **Delta F2 Min** - using Debug version of user interface only

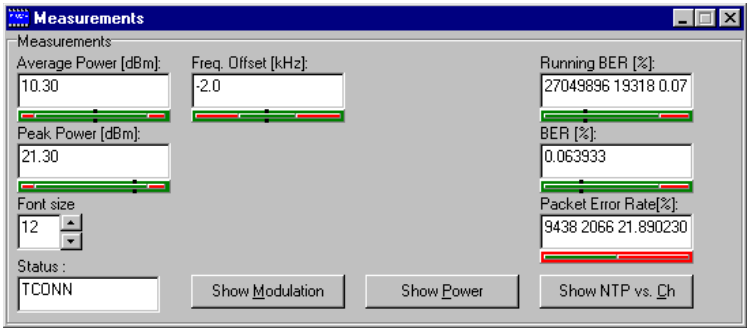


Figure 23 Loopback Test Measurements Window

RF measurement parameters in Loopback DUT Mode.

The following parameters are displayed in the **Measurements** window during **Loopback Test**:

- **Average Power**
- **Peak Power**
- **Frequency Offset**
- **Running BER**
- **BER**
- **Packet Error Rate**

NOTE Some extra measurements, not in the Bluetooth specification, using remote commands. (Refer to Chapter 5, “Programming Reference” on page 79.)

Font size

To view the measurements results from a greater distance you can change the displayed size of text on the **Measurements** window. The font size is selectable from 12 to 18. (Default is 18.)

Status

The status display line shows the state of the test set or if the connection is off. Colour coding is also used to indicate the state. (Refer to Chapter 5, “Programming Reference” on page 79 about the SCPI states).

Show/Close Measurement Graphs

When a Bluetooth connection is established, the graph windows can be opened and/or closed. Pressing **Show Modulation**, **Show Power**, and **Show Power vs. Ch** displays the graphs as shown in Figure 24, Figure 25, and Figure 26. When a graph is displayed, the associated button changes to **Close**.

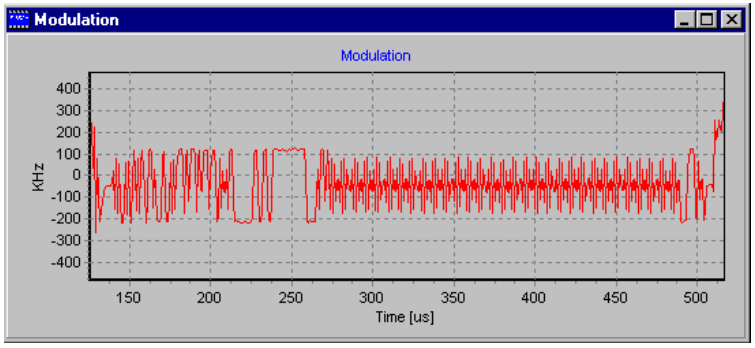


Figure 24 Modulation Display

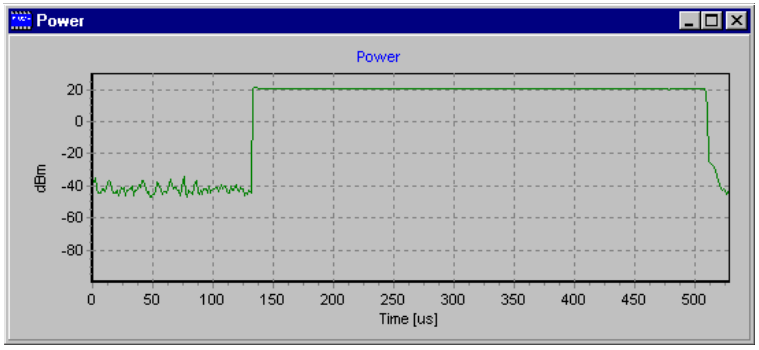


Figure 25 Power Display

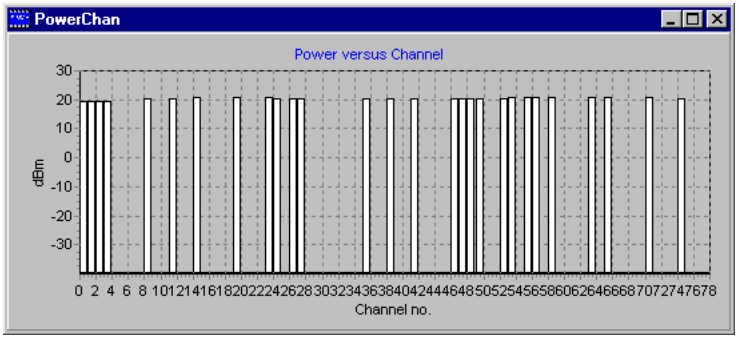


Figure 26 Power vs. Ch Display

NTP (average power) is measured for each channel. PTP (peak power) cannot be obtained from this measurement. The Power vs. Channel display can be captured even when the DUT is in random frequency hopping mode. Simply wait for the channels to be visited

Zoom function in the graph windows

You can zoom in and out on the three graph windows by left clicking and dragging the mouse.

Begin in the upper left corner of the graph. Left click and drag a rectangle to the lower right and release the mouse button. Now right click in the display and slide the graph to view the area of interest.

Left click in the lower right and drag to the upper left to return to the normal viewing.

Normal Mode Page

Normal Mode is used to make RF measurements in a Bluetooth connected link where the Bluetooth test mode is not required or is not supported in the DUT. **Normal Mode** test facilities can be used to quickly determine the performance of the DUT prior to implementing more comprehensive measurements in Bluetooth Test Mode.

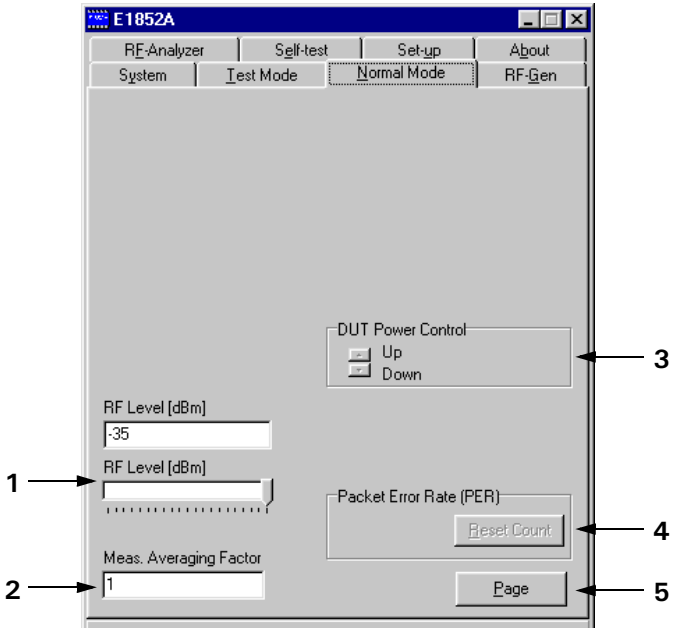


Figure 27 Normal Mode Page

Normal Mode Page structure

The **Normal Mode** page contains the following panels and entry fields:

1. RF Level

The RF power level in the test set transmit direction can be adjusted for sensitivity measurements.

The power levels, with attenuation, can be adjusted from –55 to –95 dBm, and without attenuation from –35 to –75 dBm.

The power level can be entered directly in the **RF Level [dBm]** field or adjusted by moving the **RF Level** slider.

2. Meas. Averaging Factor

You can choose to make measurements on single packets or average the results over a number of packets up to a maximum of 999. A lower number updates the measurement more frequently.

3. DUT Power Control

If the DUT supports this feature, you can use the up/down buttons to control its RF output level.

4. Packet Error Rate (PER)

The Packet Error Rate is displayed on the Normal Mode **Measurements** window.

5. Page/Release

The **Page/Release** button opens or closes a Bluetooth RF connection between the test set and the DUT. Clicking **Page** opens a **Measurements** window. When a Bluetooth connection is established, the **Measurements** window is displayed. Also the **Page** button changes to **Release**.

Clicking **Release** closes the connection.

NOTE Closing the **Measurements** window also releases the connection to the DUT

Measurements Window

When a Bluetooth connection is established, the **Measurements** window opens.

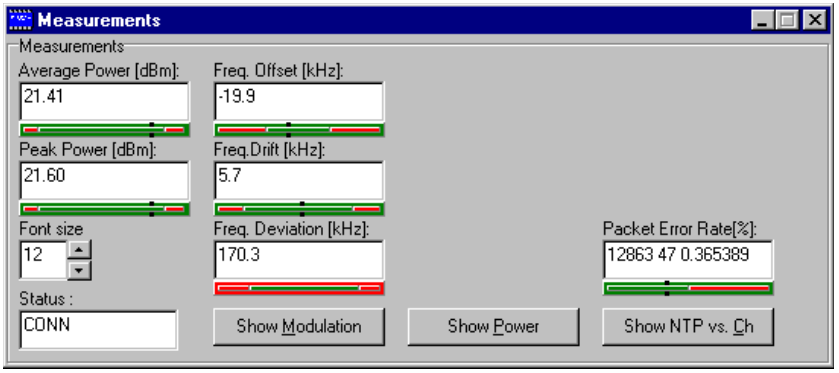


Figure 28 Normal Mode Measurements Window

RF measurement parameters in Normal Mode.

- **Average Power**
- **Peak Power**
- **Frequency Offset**
- **Frequency Drift**
- **Frequency Deviation**
- **Packet Error Rate**

NOTE Frequency Drift and Frequency Deviation are good indicators of the DUT performance. They cannot be made in exactly the same way as Testmode because the payload is different.

Table 3 Normal Mode Page - Panel Summary

	Panel	Parameters	Description
1.	RF Level	-55 to -95 dBm with attenuation -35 to -75 dBm without atten.	Entry field or slider to control the RF level
2.	Meas. Averaging Factor	1 to 999	Selects the number of packets to be used for the measurement
3.	DUT Power Control	variable	Enables adjustment of DUT RF level (if supported by DUT)
4.	PER		PER is displayed on the Measurements window. Pressing Reset Count resets and restarts the running count

RF-Gen Page

The **RF-Gen** (RF-Generator) page is used to generate RF signals from the test set on a selected channel within the specified Bluetooth radio band. It can be very useful to check a DUT that cannot establish a link or to calibrate a parameter such as Receive Signal Strength Indication (RSSI).

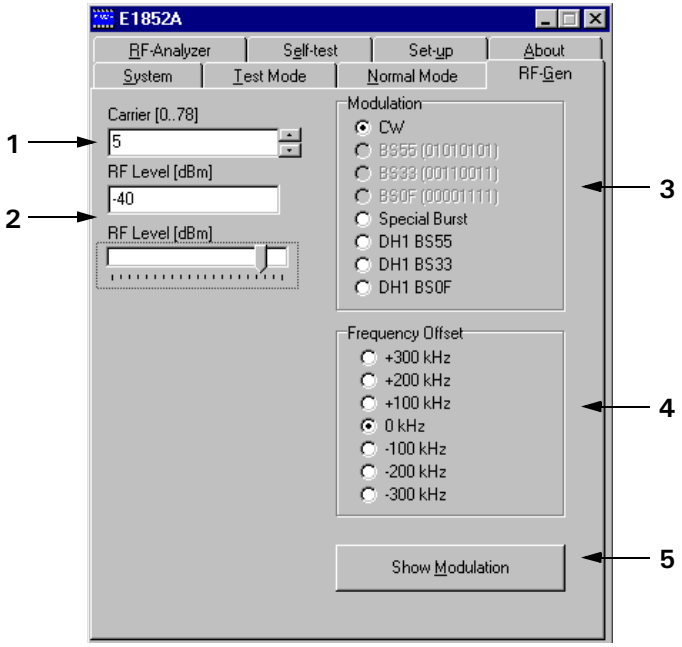


Figure 29 RF-Generator Page

RF-Gen Page structure

The **RF-Gen** page contains the following panels and entry fields:

1. Carrier

The carrier frequency can be chosen by selecting one of the 79 channels on the ISM band (channel 0 – 78 ~ 2.402 – 2.480 GHz).

Channel 40 is the mid frequency at 2.442 GHz.

2. RF Level

The RF power level in the test set transmit direction can be adjusted for sensitivity measurements.

The power levels, with attenuation, can be adjusted from –55 to –95 dBm, and without attenuation from –35 to –75 dBm.

The power level can be entered directly in the **RF Level [dBm]** field or adjusted by moving the **RF Level** slider.

3. Modulation

5 modulation patterns are available (**CW**, **Special Burst**, **DH1 BS55**, **DH1 BS33**, and **DH1 BS0F**). The modulation patterns are shown in Figure 30, Figure 31, Figure 32, and Figure 33.

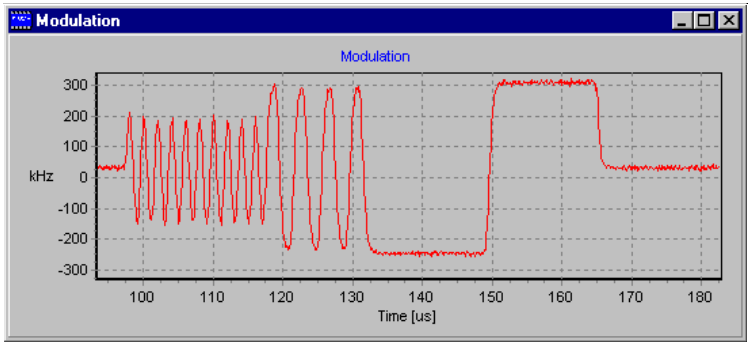


Figure 30 Special Burst

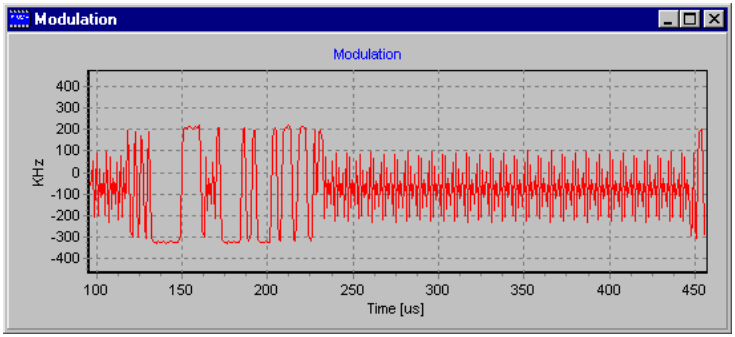


Figure 31 DH1 BS55

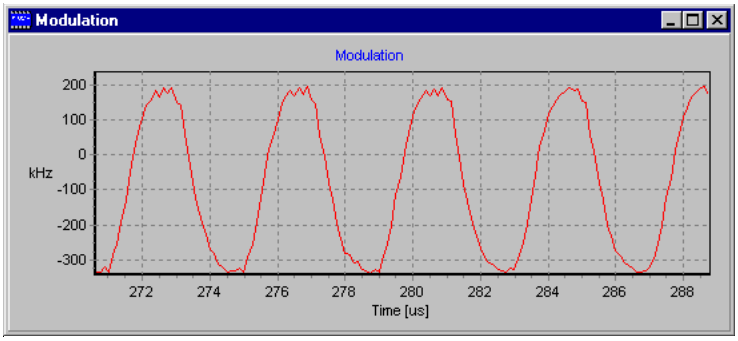


Figure 32 DH1 BS33

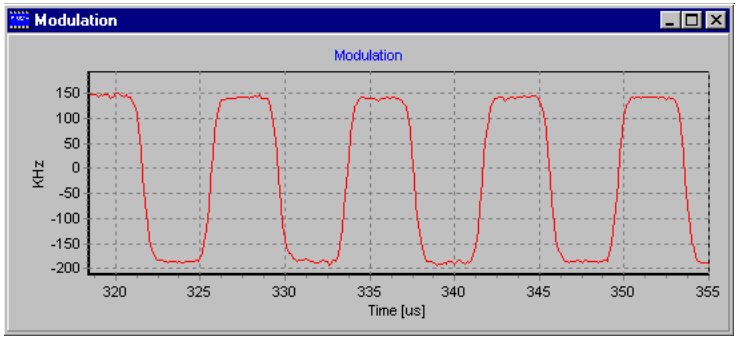


Figure 33 DH1 BS0F

4. Frequency Offset

You can apply an offset to the carrier signal from –300 kHz to +300 kHz in 100 kHz steps. This can be used to check how a receiver performs under extreme conditions.

5. Show Modulation

Clicking **Show Modulation** opens the **Modulation** graph window showing what is being transmitted.

Table 4 RF-Gen Page - Panel Summary

	Panel	Parameters	Description
1.	Carrier	0 to 78	Entry and display of the ISM band channel number (0-78, 2.402-2.480 GHz)
2.	RF Level	-55 to -95 dBm with attenuation -35 to -75 dBm without atten.	Entry field or slider to control the RF level
3.	Modulation	CW, Special Burst, DH1 BS55, DH1 BS33, and DH1 BS0F	Selects the modulation pattern required.
4.	Frequency Offset	0 khz, ±100kHz, ±200 kHz and ±300 kHz	Selects the frequency offset required

RF-Analyzer Page

The **RF Analyzer** page can make RF measurements on the DUT without first establishing a Bluetooth connection. A Measurements window is displayed when the RF-Analyzer page is selected.

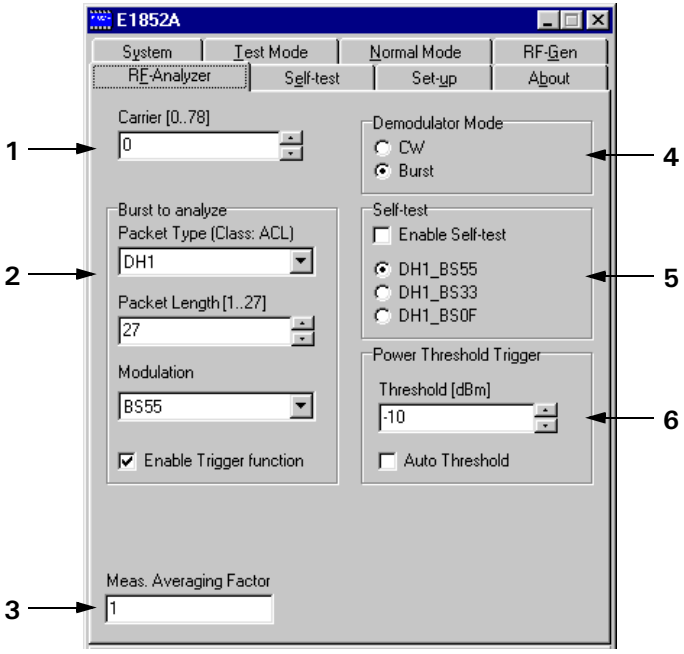


Figure 34 RF-Analyzer Page

RF-Analyzer Page structure

The **RF-Analyzer** page contains the following panels and entry fields:

1. Carrier

The carrier frequency can be chosen by selecting one of the 79 channels on the ISM band (channel 0 – 78 ~ 2.402 – 2.480 GHz).

Channel 40 is the mid frequency at 2.442 GHz.

2. Burst to analyze

The **RF-Analyzer** only requires the channel number to be specified if you are making measurements on a DUT transmitting a CW signal. If however, you want to measure a specific burst transmitted by the DUT, you must ensure the **RF-Analyzer** is configured with the same burst parameters. First configure the following:

- **Packet Type** - select the specific single or multi slot package transmitted by the DUT. The supported packet types are:
  - **DH1** to **DH5**
- **Packet Length** - select the packet length being transmitted by the DUT. Supported lengths are:
  - **1** to **27** for **DH1** single slot packets
  - **1** to **183** for **DH3** multi slot packets
  - **1** to **339** for **DH5** packets.
- **Modulation** - select the modulation patter being transmitted by the DUT. Supported patterns are:
  - **BS0F**
  - **BS33**
  - **BS55**

3. Meas. Averaging Factor

You can choose to make measurements on single packets or average the results over a number of packets up to a maximum of 999. A lower number updates the measurement more frequently.

4. Demodulator Mode

To measure a CW signal only at the channel number specified, simply select **CW**. To make measurements on a DUT transmitting a burst as specified in the **Burst to analyze** panel, click Burst.

5. Self-test

The 'Enable Self-test' check-box allows you to make a limited measurement of the test set. The output signal is looped-back internally and the results displayed. This is a useful check of test set performance and can be used to gain familiarity with Bluetooth RF signals.

6. Power Threshold Trigger

You can set the threshold value for the power envelope of the bluetooth burst when the Burst Demodulator Mode is enabled. This value used when the measurement attempts to find the power envelope of the applied bluetooth signal.

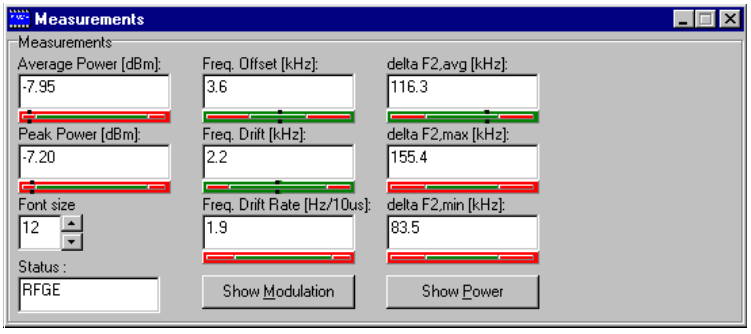


Figure 35 RF-Analyzer Measurements - BS55 Modulation Pattern

Table 5 RF-Analyzer Page - Panel Summary

	Panel	Parameters	Description
1.	Carrier	0 to 78	Entry and display of the ISM band channel number (0-78, 2.402-2.480 GHz)

	Panel	Parameters	Description
2.	Burst to analyze	Packets DH1 to DH5, HV3 and AUX1 Packet Lengths 1 to 27 for DH1, 1 to 183 for DH3, 1 to 339 for DH5 Modulation patterns BS0F, BS33, BS55	Entry and display fields for information required when making measurements in Burst Mode
3.	Meas. Averaging Factor	1 to 999	Selects the number of packets to be used for the measurement
4.	Demodulator Mode	CW or Burst	Selects the required measurement method
5.	Self Test	DH1_BS55 DH1_BS33 DH1_BS0F	Selects Self Test mode and the data packet/modulation to be measured
6.	Power Threshold Trigger	variable	Specifies the burst power trigger level

Self-test Page

Using the **Self-Test** page, you can quickly verify the operating status of the test set.

NOTE Ensure any connection to the **RF IN/OUT** port is removed.

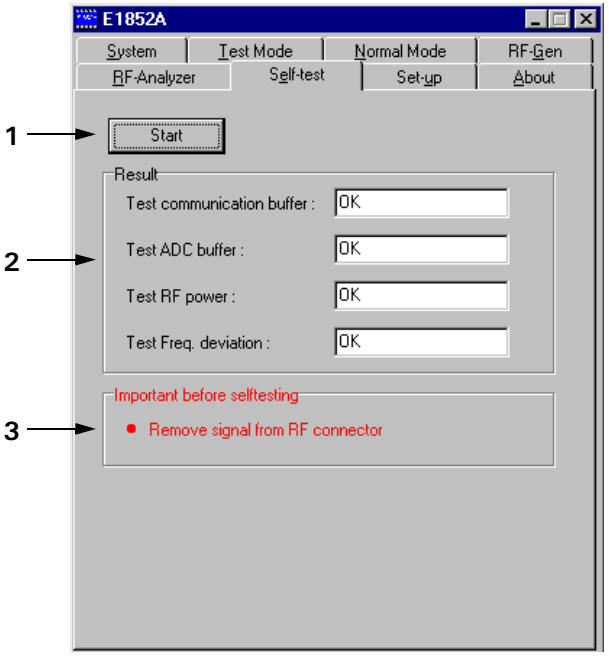


Figure 36 Self-test page

Self-test Page structure

The **Self-test** page contains the following panels and entry fields:

1. Start

Click the **Start** button to begin verification of the test set.

2. Result

The 4 self-test results are displayed in the associated fields.

- **Test communication buffer:**
- **Test ADC buffer:**
- **Test RF power:**
- **Test Freq. deviation:**

OK is shown in the display fields when each test has been completed successfully. If a test fails, an error message is displayed. When an error condition occurs first power cycle the test set and rerun the tests. If the error condition persists contact your nearest Agilent Technologies Sales and Service Office (see Contacting Agilent Technologies on page 145.)

3. Reminder

You are reminded to remove any connection to the **RF IN/OUT** port.

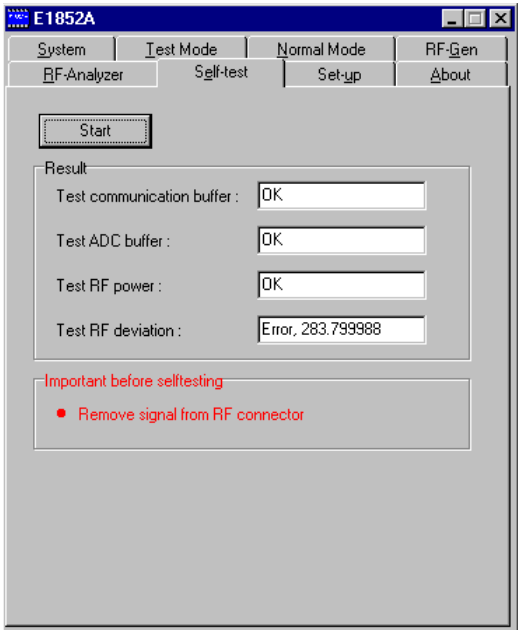


Figure 37 Self-test Error message

Set-up Page

The **Set-up** page provides a limits matrix where you can enter pass and fail values for the measurement parameters. You can quickly configure parameters using the save/recall function to setup previously saved settings. The data entered in this page is used to specify the scale of the red/green bar indicators on the **Measurements** windows..

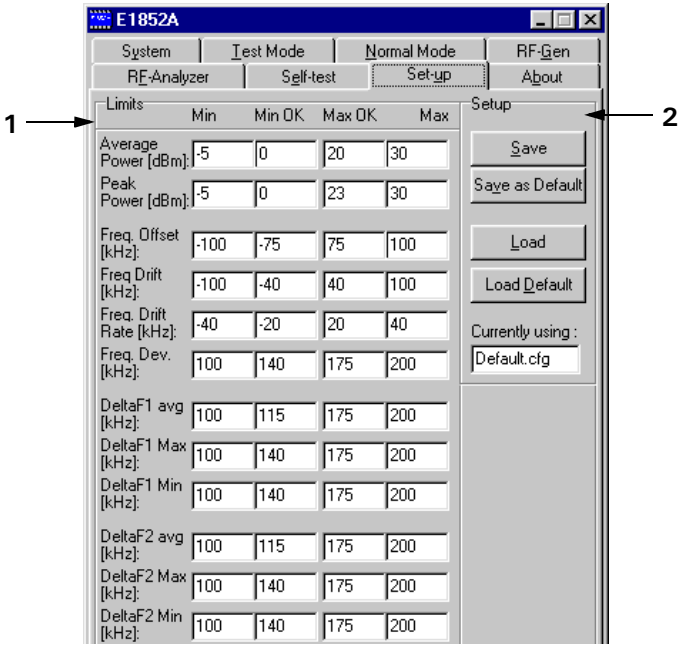


Figure 38 Set-up Page

Set-up Page structure

The **Set-up** page contains the following panels and entry fields:

1. Limits

You can use the entry fields to enter and display the required limits. The parameters are as follows:

- **NTP**
- **PTP**
- **Frequency Offset**
- **Frequency Drift**
- **Frequency Deviation**
- **Delta F1 avg**
- **Delta F1 Max**
- **Delta F1 Min**
- **Delta F2 avg**
- **Delta F2 Max**
- **Delta F2 Min**

How the Limits are used

4 limits are required for each parameter. **Min**, **Min OK**, **Max OK**, and **Max** are used to scale the red/green bars for each of the associated parameters on the **Measurements** windows. (see Figure 39 on Page 54)

- **Min** and **Max** limits set the end points of the bar.
- **Min OK** and **Max OK** limits set the position and size of the green 'OK' or 'Pass' section.
- Sections of the bar between the **Min OK** and **Max OK** regions are colored red to indicate a 'Fail'.
- The measurement result is shown numerically in the display field. It is also indicated along the length of the bar by a marker.
- The background area is red when the result is outside the 'OK' limits and changes to green when within the 'OK' limits. (see Figure 39 and Figure 40 on Page 54)

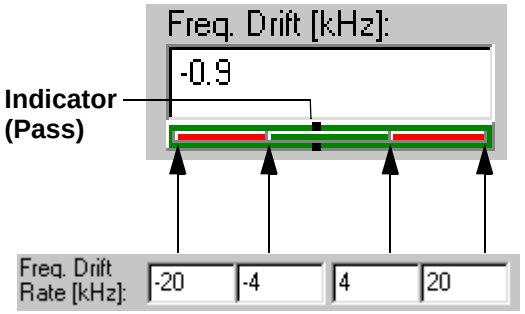


Figure 39 Frequency Drift Limits and Display Bar (Pass)

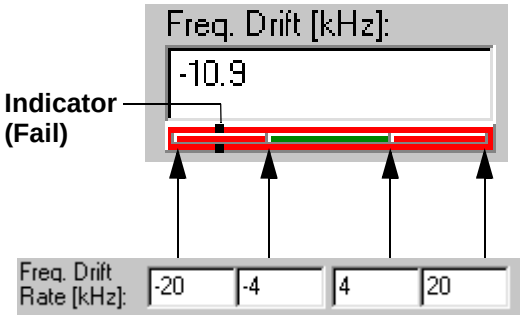


Figure 40 Frequency Drift Limits and Display Bar (Fail)

2. Setup

Setup files provide a convenient and quick method of changing the values in the **Limits** fields. All the values you have entered in the **Limits** fields can be saved in a setup file (.cfg file extension). A setup file can be loaded again to reconfigure the limits to the required values. The name of the set-up file in use is displayed in the **Currently using:** display line.

Saving and loading setup files

Clicking **Save** opens a dialog window where you can choose the file and path name to create a setup file of the current values. Save these in a folder other than the test set application folder to prevent them being lost if the application folder is uninstalled.

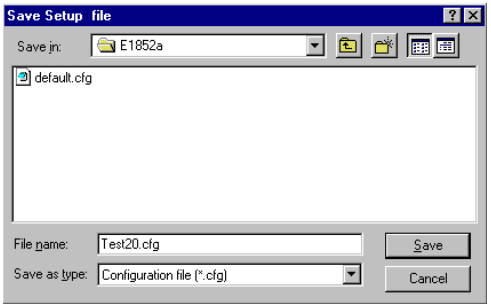


Figure 41 Save Setup dialog window

Clicking **Load** opens a dialog window for you to choose the required file.

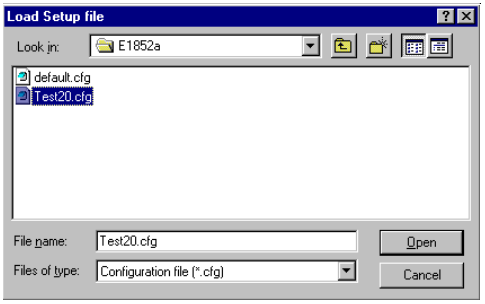


Figure 42 Load Setup dialog window

Saving and loading the default setup file

You can save the current set of **Limits** as the default configuration by clicking **Save as Default**. the current configuration is saved as default.cfg. To restore the Limits to your chosen default configuration click **Load Default**.

About Page

The **About** page details the version and date of the user interface.

This information can be useful when support from Agilent Technologies is required.

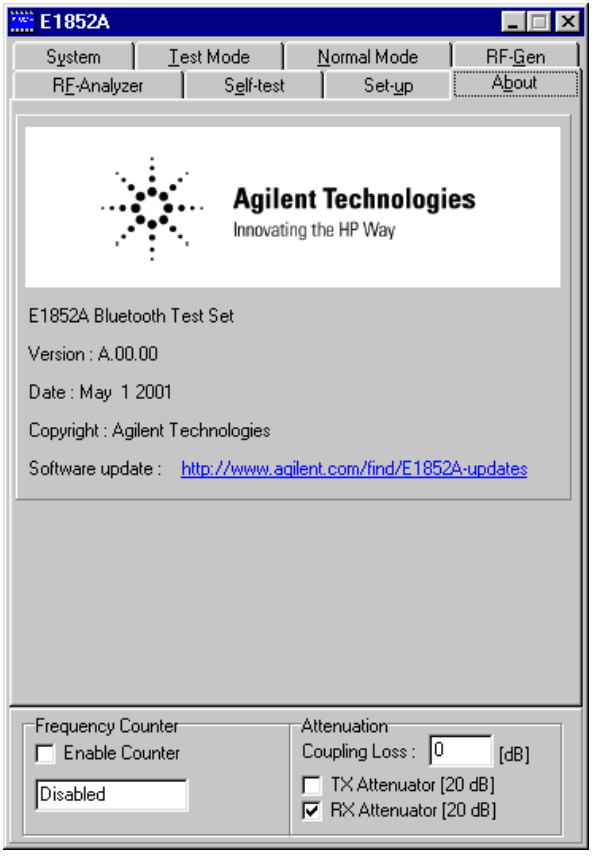


Figure 43 'About' page

3 Making measurements

What You'll Find In This Chapter

This Chapter shows you how to quickly set up the test set for measurements.

It contains these sections:

Configuring the System for Measurements

Getting started

Confirm all the required connections have been made between your PC and the test set. Connect the test set to the DUT using an RF cable.

NOTE To maintain regulatory compliance, antenna connection to the DUT must be carried out within a screened environment. Also, an antenna connection can introduce significant errors.

On the Windows Interface

Double click the E1852A Bluetooth Test Set icon on your PC desktop.

System Click the **System** tab:

- Make sure the **DUT BD address** is correct for the DUT in use.

Test Mode To configure a Bluetooth Test Mode connection with the DUT click the **Test Mode** tab:

- Select the required Bluetooth parameters such as **Frequency Hopping Mode**.
- Select **RF Level** of the test set.
- Select the DUT Mode – **Transmitter Test** or **Loopback**.
- Select the required **Modulation** pattern.
- Use the controls supplied for the DUT to ensure that it is setup to make a Bluetooth test mode connection.
- Click **Page** to make a Bluetooth connection in Test Mode.

NOTE The test set is configured at shipment for Bluetooth 1.1 compliant device testing. Refer to SYSTem:BT:VERS<version> on page 118 to configure the test set for version 1.0B. You must manually change back to Bluetooth 1.1 test set configurations

Normal Mode

To configure a Bluetooth Normal Mode connection with the DUT click the **Normal Mode** tab:

- Select **RF Level** of the test set to ensure sufficient signal power reaches the DUT input.
- Use the controls supplied for the DUT to ensure that it is setup to make a normal Bluetooth connection.
- Click **Page** to make a Bluetooth connection in Normal Mode.

RF Analyzer Mode

To configure RF Analyzer measurements click the **RF-Analyzer** tab:

- Select the DUT transmission channel in the **Carrier [0..78]** entry field
- Select modulated signal measurements (**Burst**) or
- Un-modulated signal (**CW**) measurements.
- If **Burst** is selected, choose the required parameters.

NOTE Changes to DUT settings can only be made using the application provided by your module or device supplier.

Power Measurements

Peak and average RF Power of the DUT can be measured in both Normal and Test Modes.

Average Power

Test Mode With a Test Mode connection, average power is measured by sampling the power value over the main part of the full Bluetooth burst. Average power measurements can be obtained in transmitter tests as well as in receiver tests with selectable packet types and modulation pattern.

Normal Mode With a Normal Mode connection , average power is measured by sampling the power values within the Access Code part of the Bluetooth burst. An average is made over 10 samples.

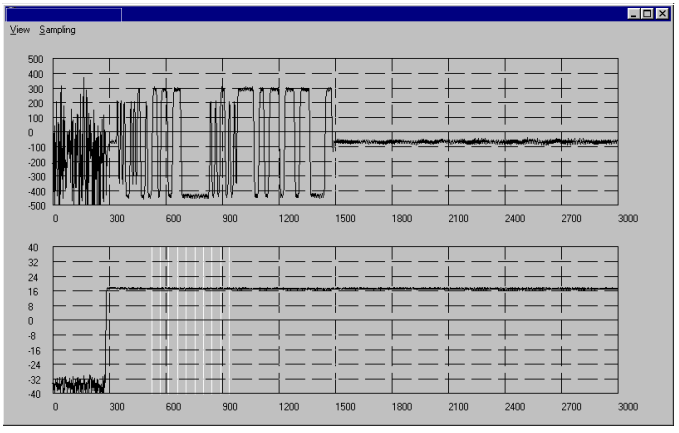


Figure 44 Average Power Measurement

Peak Power

With both Normal and Test Mode connections, Peak Power is measured in the beginning of the Bluetooth burst, where the power peak is expected.

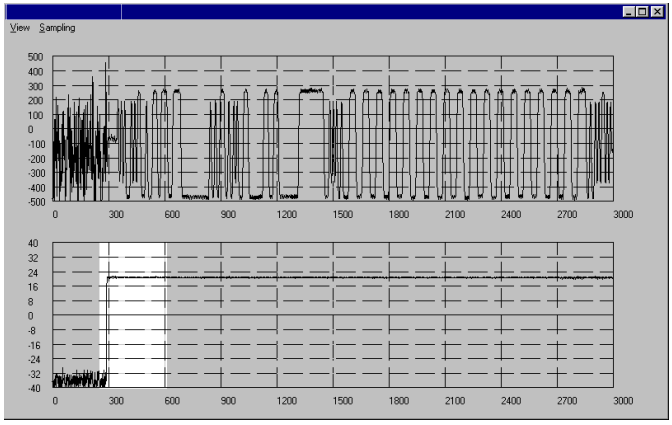


Figure 45 Sampled Modulation

Remote Commands

The power values can be read out by using the SCPI commands:

`READ:NTP?` For measuring Average Power and

`READ:PTP?` For measuring Peak Power.

Frequency and Modulation Measurements

Some frequency and modulation measurements can only be carried out in test mode when the correct packet type is selected. In this case the measurements are made in accordance with the Bluetooth specification.

- Frequency Drift - Both Normal and Test Mode
- Frequency Drift Rate - Test Mode only
- Frequency Deviation
- DELTA_F1
- DELTA_F2
- Frequency Offset

Frequency Drift Measurement

Test Mode

In accordance with the Bluetooth specification, the frequency drift measurement is made with the modulation pattern BS55 (01010101) and with packet types DH1/DH3/DH5.

The average frequency of each 10 bits of the payload is calculated. Each calculation is compared with the average frequency of the 4 preamble bits. The greatest difference (worst case) is used as the measurement result.

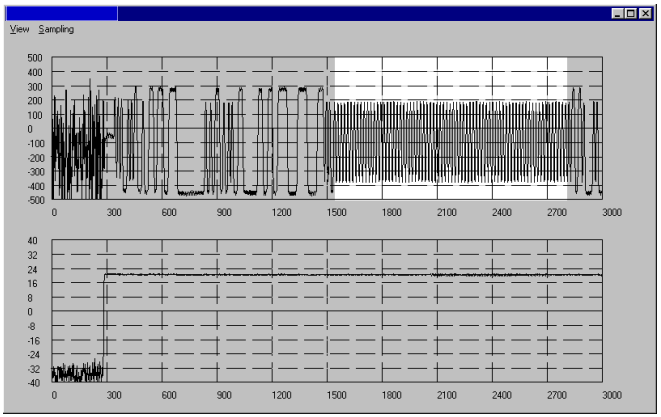


Figure 46 Test Mode - Frequency Drift Measurement

The frequency drift value measured in accordance with the Bluetooth specifications can be read out by using the SCPI command:
`READ:FREQ:DRIF:SPEC?`

Normal Mode

Sampling from the Access Code trailer part of the Bluetooth burst is used to give an approximation of frequency drift. The difference between this average frequency value and the frequency-offset value (measured at the preamble part) is the frequency drift. Normal mode does not allow a drift measurement to be made in accordance with the Bluetooth specification .

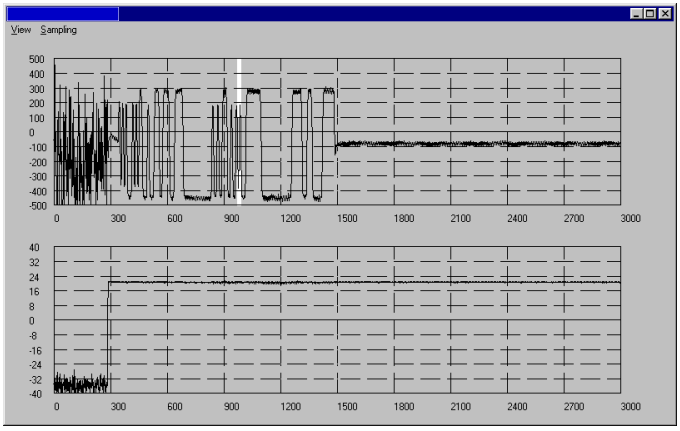


Figure 47 Normal Mode - Frequency Drift Measurement

Remote Commands

The frequency drift value can be read out by using the SCPI command:
`READ:FREQ:DRIF?`

Frequency Drift Rate Measurement

This measurement reuses the data from frequency drift measurement.

Test Mode

For every group of 10 bits, the measured frequency drift is compared with the 2 adjacent 10 bit groups. The differences found are the frequency drift rate. The maximum difference (worst case) is taken as the result of the measurement.

The frequency drift rate can be read back using the SCPI command:
`READ:FREQ:DRIF:SPEC:RATE?`

NOTE The drift and drift rate measurements are sensitive to noise from the DUT. Results can vary significantly between consecutive measurements.

Frequency Deviation

Normal Mode

It is not possible to measure the standard modulation characteristics Delta F1 and Delta F2 with a Normal Mode connection. Instead, this test uses the Access Code part of the burst. 111/000 patterns are used to approximate the Delta F1 result while the Delta F2 result is estimated using 101/010 patterns

The values can be read using the SCPI commands
`READ:PSEUDO:DELTA_F1?` and `READ:PSEUDO:DELTA_F2?`

Delta F1 Average Measurement

Test Mode

This deviation measurement is specified in the Bluetooth RF test specification under Transmitter Test as Modulation Characteristics.

In accordance with the specification, the measurement modulation pattern is BS0F (00001111 bits), and the packet type is DH1/DH3/DH5.

For each byte within the payload, the frequency deviation is calculated for the bits 2, 3 and 6,7 (Delta F1 max. values). The average for all bytes is then taken as the Delta F1 Average value.

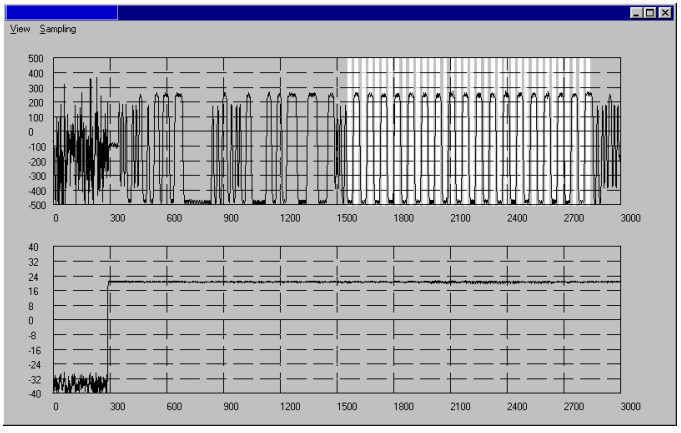


Figure 48 Delta F1 Measurement

The Delta F1 average value according to the Bluetooth specifications can be read out by using the SCPI command: `READ:DELTA_F1?`

Delta F2 Average Measurement

Test Mode

This test is specified in the Bluetooth RF test specification under Transmitter Test as Modulation Characteristics.

In accordance with the specification, the measurement modulation pattern is BS55 (01010101 bits), and the packet type is DH1/DH3/DH5.

For each byte within the payload, the maximum frequency deviation is calculated for the 8 bits (Delta F2 max. value). The average for all bytes is then taken as the Delta F2 Average value.

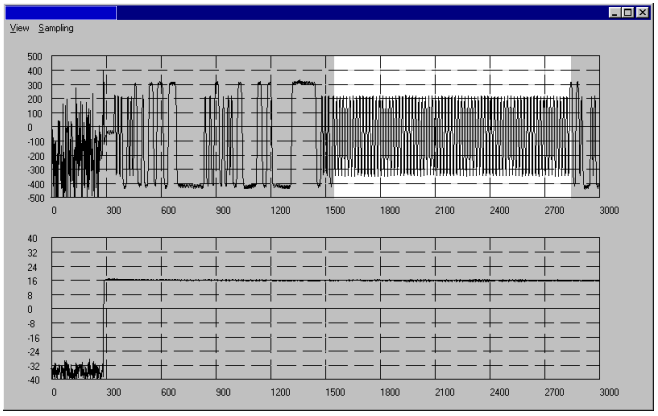


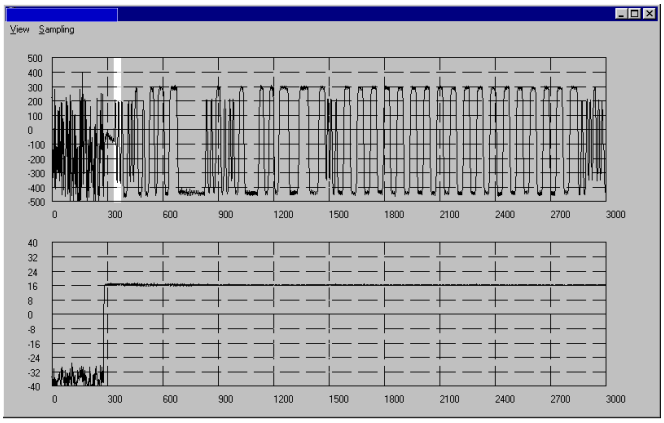
Figure 49 Delta F2 Measurement

The Delta F2 average value according to the Bluetooth specification can be read out by using the SCPI command: `READ:DELTA_F2?`

Frequency Offset Measurement (ICFT)

Normal and Test Modes

This measurement is carried out by identifying the preamble part of the Bluetooth burst. The preamble is sampled and the average value gives the Frequency Offset value.



The Frequency Offset value can be read out by using the SCPI command:
`READ:FREQ:OFFS?`

NOTE On some types of devices results can vary significantly between consecutive measurements.

Sensitivity Measurements

The sensitivity of the DUT is determined using a Bit Error Rate (BER) or a Packet Error Rate test.

Bit Error Rate

Test Mode

This sensitivity measurement is carried out by examining every bit in the received payload. The payload used is SPSR (Static Pseudo Random, PN9).

The Bit Error Rate measurement is available with 'running' measurements, where the received payload is measured continuously, and in a static measurement where you can define the number of bits to be used.

The Bit Error Rate values can be read out by using the SCPI commands:

`PROC:BER:START <numeric value>` (To specify the number of bits to be used in the measurement)

`READ:BER?` (measurement according to the Bluetooth specification).

`FETCH:BER?` (returns the number of bits transferred, erroneous bits detected and running BER%)

Packet Error Rate

This test is a sensitivity measurement used in both Normal Mode and Test Mode.

The test measures the number of lost packets (Not ACKnowledged = NACK), compared to the total number of packets transmitted.

The Packet Error Rate values can be read out by using the SCPI commands:

PROC:NACK:START <numeric value>

READ:NACK?

FETCH:NACK? (returns the number of packets transferred, erroneous packets detected and running PER%)

4 DLL Interfacing

What You'll Find In This Chapter

This chapter shows you how the Dynamic Link Library (DLL) is used to communicate with the test set.

It contains these sections:

Introduction

The purpose of this chapter is to help the you develop your own Bluetooth test applications in the test executive you intend to use. In order to successfully control the E1852A Bluetooth Test Set using the SCPI command set, you must first understand how to link to the supplied E1852A Dynamic Link Library (DLL).

Once this is understood, consult the Programming Reference on page 79 for information on the functionality provided by the DLL.

Windows provides many ways to use dynamic link libraries and various programming/compiler tools adopt slightly different approaches to DLL linking. In this chapter the most common ways to perform DLL linking using Windows WIN32 C++ API are described. Minor adaptations may be necessary when other programming tools are used.

Terms Used

DLL: Windows Dynamic Link Library

API: Application Program Interface

DLL Interface

The parallel port is used to communicate with the E1852A bluetooth test set. The commands required for parallel port operation are primitive, involving the use of 'peek' and 'poke' commands to transfer data and functions. The Dynamic Link Library (DLL) acts as a translator between the SCPI commands and the parallel interface commands. An overview of the DLL Interface function is shown in Figure 50.

The DLL is available for use by your own test application as shown in the section Calling Convention on page 72.

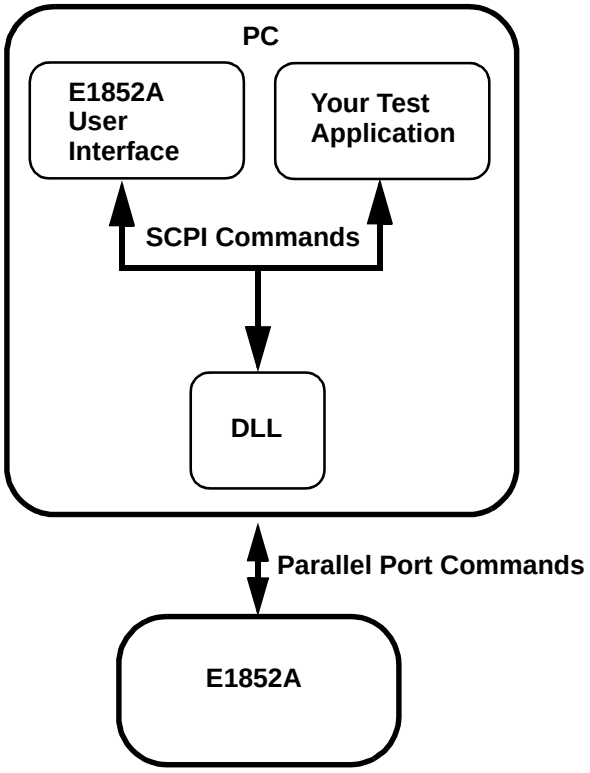


Figure 50 The E1852A Dynamic Link Library (DLL)

Calling Convention

Different programming languages and compilers use different approaches when performing subroutine calls. The methods used to store parameters, return addresses etc. on the stack vary. This is called *the calling convention*.

Since the Application may not have been created in the same programming language as the DLL, it becomes necessary to know the calling convention to use when DLL functions are called.

The calling convention used by the E1852A test set DLL is the **__stdcall**.

When C++ is used as the Application Programming language, the calling convention is explicitly specified by the **__stdcall** keyword in the interface header file E1852Adll.h.

Explicit DLL Linking

With *Explicit Linking*, the Application only requires the interface header file E1852Adll.h and the DLL itself. All DLL linking is done explicitly by the application program.

Using this approach you must first load the DLL module using the WIN API function:

- LoadLibrary(DLL filename)

Thereafter you must retrieve the addresses for each DLL function explicitly.

- functionPtr = GetProcAddress(DllHandle, function name)

An example is shown below:

```
//---------------------------------------------------------------
//  Microsoft Visual C++ 6.0 Win32 Console Demo Application
//  demonstrating how to use the dll-interface of the E1852A.
//
//  Agilent Technologies, 2001
//---------------------------------------------------------------
/
*****************************************************************
*                          Include files
*****************************************************************
/
#define E1852A_VARS   // Tells the E1852Adll.h that we want to
                      // declare the Dll interface functions as
                      // function-pointers, which are then loaded
                      // explicitly.
#include "E1852Adll.h"
#include "Win32Err.h"
#include "stdio.h"

/*****************************************************************
*                         Macro definitions
*****************************************************************
/
#define E1852A_DLL_NAME "E1852ADLL.Dll"
#define LOADFUNC(fname) \
  fname = GetProcAddress(DllHandle, #fname); \
```

```
  if (fname == NULL) \
  { \
    ShowWin32Error(#fname " not found in " E1852A_DLL_NAME); \
    return FALSE; \
  }
/
*****************************************************************
*                     Enumerations/Type definitions/Structs
*****************************************************************
/
/
*****************************************************************
*                      Global variables/const
*****************************************************************
/
/
*****************************************************************
*                      Local variables/const
*****************************************************************
/
static HINSTANCE DllHandle;
char ScpiStr[200];
char ResponseStr[200]
/
*****************************************************************
*                    Local Function prototypes
*****************************************************************
/
/
*****************************************************************
*                           Implementation
*****************************************************************
/
/
*****************************************************************
* DESCRIPTION:
*****************************************************************
/
boolean LoadDll(void)
{
  // First load the DLL library
  if (DllHandle == NULL)
  {
    DllHandle = LoadLibrary(E1852A_DLL_NAME);
    if (DllHandle == NULL)
```

```
      DllHandle = LoadLibrary("." E1852A_DLL_NAME);
    if (DllHandle == NULL)
    {
      ShowWin32Error(E1852A_DLL_NAME);
      return FALSE;
    }
// Then setup function pointers.
    #ifdef __BORLANDC__
    #pragma warn -8075
// Avoid Borland warning
    #endif
    #pragma warning( disable : 4057)  // Avoid Microsoft VC warning
    #pragma warning( disable : 4133)  // Avoid Microsoft VC warning
    #pragma warning( disable : 4113)  // Avoid Microsoft VC warning
LOADFUNC(RtxWrt);
LOADFUNC(RtxRd);
  }
  return TRUE;
}
/
*********************************************************************
* DESCRIPTION:
*********************************************************************
/
void UnloadDll(void)
{
  if (DllHandle != NULL)
  {
    FreeLibrary(DllHandle);
    DllHandle = NULL;
  }
}
// End of file.
/
*********************************************************************
* DESCRIPTION:
*********************************************************************
/
void SendScpiCommand(char* ScpiStr)
{
  uint16 Errors;
// Send SCPI command
  printf("SCPI command        : %s",ScpiStr);
  Errors = RtxWrt((far int8 *)ScpiStr);
```

```
  printf("\nSCPI Errors detected: %d",Errors);
// Read the response
  RtxRd((int8 *)ResponseStr);
  printf("\nSCPI response       : %s\n\n",ResponseStr);
}
/
*********************************************************************
* DESCRIPTION:
*********************************************************************
/
int main(int argc, char *argv[])
{
  printf("\nAgilent Technologies, 2001\n");
  printf("\nMicrosoft Visual C++ 6.0 Win32 Console Demo
Application.");
  printf("\nDemonstrating how to use the dll-interface of the
E1852A.\n\n");
  if(LoadDll())
  {
// Demonstrate different SCPI commands
    SendScpiCommand("SYST:PC:VERS?");
    SendScpiCommand("SYST:FIRM:VERS?");
    SendScpiCommand("STAT:DEV?");
  }
  return 0;
}
```

Implicit DLL Linking

With *Implicit Linking* the Application requires the interface header file E1852Adll.h **plus** the E1852Adll.lib file (and the DLL itself).

The DLL linking is now done implicitly by the compiler used for creating the Application program. The compiler will recognize this because of the keyword **__declspec(dllimport)** specified in the interface header file. The information needed for the compiler to perform this linking is included in the .lib file. The lib file shall therefore be included in the source file list of the Application project.

Unfortunately there seems to be compiler differences between .lib formats. **Therefore it is recommended to use the implicit DLL linking method only with Borland compilers**. In other cases (e.g. Microsoft), the explicit DLL linking method is recommended.

Agilent Vee Pro DLL Linking

When using the DLL with an Agilent Vee Pro Application it is necessary to use a special interface header file. The Agilent Vee Pro cannot interpret the conditional compiler directives within E1852Adll.h. The special interface header file, is therefore basically a stripped down version of the E1852Adll.h file.

This approach may also be necessary in other situations.

5 Programming Reference

What You'll Find In This Chapter

This Chapter lists and describes the remote command set.

It contains these sections:

General Format

The general command format is:

```
RtxWrt(command-string)
```

More commands may be concatenated into one call:

```
RtxWrt(command-string1; command-string2; .. ;
command-string N)
```

A query can be performed using the format:

```
RtxWrt(query-string?) followed by a RtxRd(result-
string)
```

NOTE `RtxWrt` is a DLL command.

The command consists of a sequence of abbreviations for some words. It is only necessary to enter the upper-case part of the words.

All commands are structured in a way analogous to the SCPI description. The upper-case letters indicate the short form of the command. The E1852A Bluetooth Test set only accepts this short form as an abbreviation (according to SCPI), otherwise the long form is used.

Introduction to the SCPI language

The SCPI (standard commands for programmable instruments) command language is recommended when you want to use the test set in high throughput manufacturing environments where the Windows user interface is not suitable.

The SCPI commands used with the test set is similar in structure to the SCPI commands used with other Agilent Technologies instruments.

The SCPI language for the test set comprises three levels set up in a hierarchy.

Example:

```
CONF  First level
       :TEST   Second level
                 :TYPE BT  Third level
```

The commands should be placed in the corresponding way in accordance with the three command levels. The condition of many of the commands can be queried by adding a '?' to the end of the string.

Example:

```
CONF:TEST:TYPE ?
```

returns `IDLE`, `BT`, `TESTMODE` or `RFGE.`

System States

The test set has four states; IDLE, BT, TESTMODE and RFGE. The reomte command set and the user interface are used to change the state according to the required task. IDLE for example, is the state immediately after power-on, system reset, or following dicconection from the DUT. In BT state, a normal Bluetooth connection is made to the DUT. Likewise, TESTMODE is the state required for a Bluetooth Test connection to the DUT. Finaly, the RFGE state is used for other measurements such as power level.

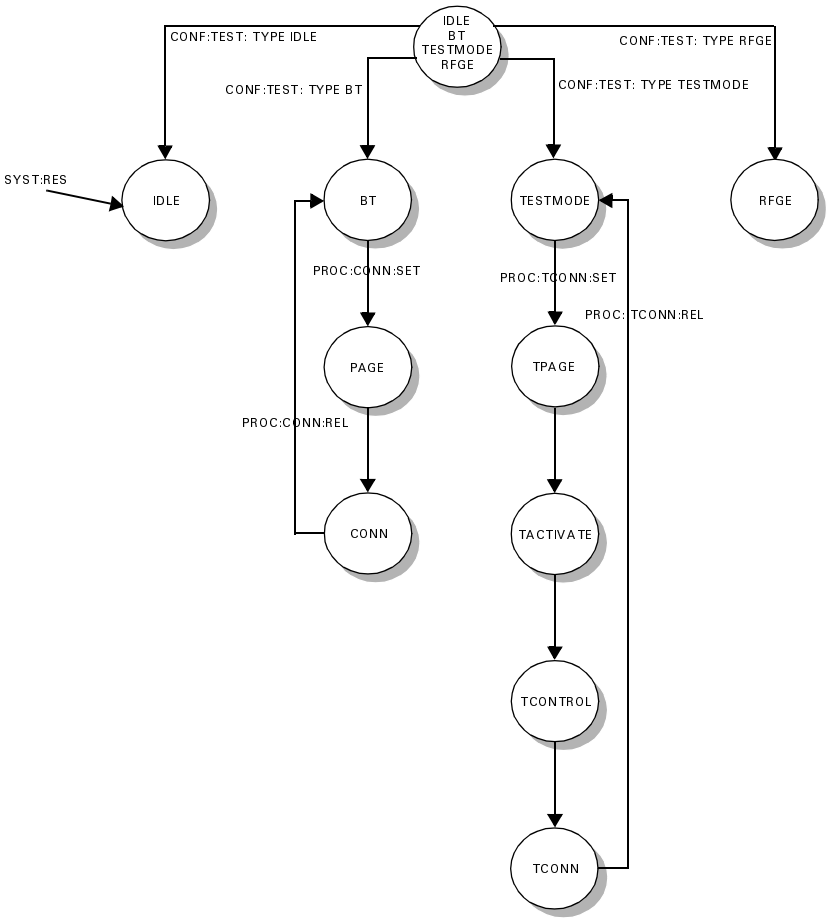


Figure 51 SCPI States

SCPI Command overview

Table 6 SCPI Command Summary

Command	
CONFigure:AVERage:BURst <value>	page 85
CONFigure:FREQuency <value>	page 86
CONFigure:HOP <value>	page 86
CONFigure:MASTer:BDADdr <value>	page 87
CONFigure:MODulation <value>	page 87
CONFigure:PACKet:LENgth <value	page 88
CONFigure:PACKet:TYPE <value>	page 89
CONFigure:POLL:PERiod <value>	page 89
CONFigure:RF:ATT_SWITch:RX <value>	page 90
CONFigure:RF:ATT_SWITch:TX <value>	page 90
CONF:RF:EXT_ATT <numeric value>	page 91
CONFigure:RF:LEVel <numeric value>	page 91
CONF:RFGEnerator:DEMOD <mode>	page 92
CONF:RFGEnerator:DEMOD:THRESH <value>	page 93
CONFigure:RFGEnerator:MODulation <value>	page 94
CONF:RFGEnerator:TUNE <value>	page 95
CONFigure:SLAVe:BDADdr <value>	page 95
CONFigure:TESTmode:MODE <value>	page 96
CONFigure:TESTmode:TYPE <value>	page 96
CONFigure:TESTmode:WAIT <setting>	page 97
FETCH:BER?	page 98
FETCH:NACK?	page 99
PROCedure:BER:START <numeric value>	page 100
PROCedure:CONNection:RELease	page 100
PROCedure:CONNection:SETup	page 101
PROCedure:NACK:START <numeric value>	page 102
PROCedure:POWer:SET <value>	page 103
PROCedure:TCONNection:CONTinue	page 103
PROCedure:TCONNection:RELease	page 104
PROCedure:TCONNection:SETup	page 104
READ:BER?	page 105

Detailed Command Descriptions

The following section lists the available commands and parameters in the individual states. The commands are listed by subsystem in alphabetical order.

Default Values are the values configured when the test set is reset.

CONFigure Subsystem

CONFigure:AVERage:BURst <value>

Number of bursts used for Measurements

Syntax:	`CONFigure:AVERage:BURst <value>`		
Value Range:	`1 to 200`	Number of bursts	Default Value: `1`
Applicable in State:	Set: All Query: All		
Description:	This command is used to configure the number of bursts used for averaging when measuring NTP, PTP, Freq.Offset, Freq.Drift and Deviation. A higher number gives more stable and precise measurements but also increases the duration of the measurements.		
Example:	`CONF:AVER:BUR 10`		Sets loopback test mode

CONFigure:FREQuency <value>

Single Frequency Selection

Syntax:	`CONFigure:FREQuency <value>`		
Value Range:	0 to 78	0 = 2402 MHz	Default Value: `0`
Applicable in State:	Set: RFGE, TESTMODE Query: RFGE, TESTMODE, TCONN		
Description:	This command configures the channel used when the test set is configured as RF Generator, or when the Hop Mode is set to single frequency in Testmode.		
Example:	`CONF:FREQ 50`		Sets channel 50

CONFigure:HOP <value>

Hop Mode selection

Syntax:	`CONFigure:HOP <value>`		
Value Range:	`Europe` `Single`	Switches hopping on Switches hopping off	Default Value: `Europe`
Applicable in State:	Set: All Query: All		
Description:	This command configures the Hop Mode used in Testmode.		
Example:	`CONF:HOP EUROPE`		Sets Hopping on

CONFigure:MASTer:BDADdr <value>

Master Bluetooth Device Address (test set)

Syntax:	`CONFigure:MASTer:BDADdr <value>`	
Value Range:	12 digits in hex format	Default Value: N/A
Applicable in State:	Set: All except CONN, and TCONN Query: All	
Description:	This command configures the Bluetooth Device Address of the test set Note: This command must be followed by a SYST:WARMSTART to take effect.	
Example:	`CONF:MAST:BDAD AEC3DD56310F`	Sets address

CONFigure:MODulation <value>

Modulation Scheme Test Mode

Syntax:	`CONFigure:MODulation <value>`		
Value Range:	`BS55`	Bit sequence 01010101 (=55 hex)	Default Value: `BS0F`
	`BS0F`	Bit sequence 00001111 (=0F hex)	
	`ONE`	Constant 1	
	SPSR	Pseudo-random bit pattern	
	`ZERO`	Constant 0	
Applicable in State:	Set: All Query: All		
Description:	This command configures the modulation used in Testmode and Transmitter test. Note, when Loopback is selected, SPSR modulation is always selected.		
Example:	`CONF:MOD SPSR`		Selects pseudo-random bit pattern

CONFigure:PACKet:LENgth <value

Packet Length selection>

Syntax:	`CONFigure:PACKet:LENgth <value>`		
Value Range:	`1 to 339`	Restrictions: AUX1: 1 to 29 bytes DH1: 1 to 27 bytes DH3: 1 to 183 bytes DH5: 1 to 339 bytes	Default Value: 27
Applicable in State:	Set: All Query: ALL		
Description:	This command configures the length of the packet sent when in test mode. The command is only applicable when using ACL packet mode. If the specified value is outside the restrictions, the value used is limited to a valid value and the ErrorCode is set to -221, settings conflict.		
Example:	`CONF:PACK:LEN 20`		Sets a 20 byte packet

CONFigure:PACKet:TYPE <value>

Packet Type selection

Syntax:	`CONFigure:PACKet:TYPE <value>`		

Value Range:	AUX1
	`DH1`
	`DH3`
	`DH5`
	`HV3`
		single width TX packet	Default Value:
			`DH1`

Applicable in State:	Set: All Query: All		
Description:	This command configures the type of packet used in test mode.		
Example:	`CONF:PACK:TYPE DH1`		Configures a DH1 packet

CONFigure:POLL:PERiod <value>

Poll Period (Transmitter Test Modes)

Syntax:	`CONFigure:POLL:PERiod <value>`		
Value Range:	`1 to 255`	Poll period [1.25 ms]	Default Value: 6
Applicable in State:	Set: All Query: All		
Description:	This command configures how often the DUT is polled by the test set in order to transmit a packet. The poll period is only used when running transmitter test, in Testmode.		
Example:	`CONF:POLL:PER 10`		Sets Poll period to 10 (12.5 ms)

CONFigure:RF:ATT_SWITch:RX <value>

Bypass RF attenuator switch in the receive direction

Syntax:	`CONFigure:RF:ATT_SWITch:RX <value>`		
Value Range:	`ON`	Normal attenuation is bypassed.	Default Value: `OFF`
	`OFF`	Normal Attenuation	
Applicable in State:	Set: All Query: All		
Description:	This command allows the user bypass the normal RF attenuation in the receive (RX) direction. Note: this also causes the input impedance of test set to increase.		
Example:	`CONF:RF:ATT_SWIT:RX ON`		Sets Attenuation On

CONFigure:RF:ATT_SWITch:TX <value>

Bypass RF attenuator switch in the transmit direction

Syntax:	`CONFigure:RF:ATT_SWITch:TX <value>`		
Value Range:	`ON`	Normal attenuation is bypassed	Default Value: `OFF`
	`OFF`	Normal attenuation	
Applicable in State:	Set: All Query: All		
Description:	This command allows the user bypass the normal RF attenuation in the transmit (TX) direction. Note: this also causes the output impedance of test set to increase.		
Example:	`CONF:RF:ATT_SWIT:TX ON`		Sets Attenuation On

CONF:RF:EXT_ATT <numeric value>

External RF attenuation compensation

Syntax:	`CONF:RF:EXT_ATT <numeric value>`		
Value Range:	`1 to 100`	[dB]	Default Value: `0.0`
Applicable in State:	Set: All Query: All		
Description:	This command states the amount of attenuation, caused by cable and connectors, applied to the RF signal between the test set and the DUT. The test set compensates for this attenuation in the measurement results.		
Example:	`CONF:RF:EXT_ATT 0.2`		Sets the value to 0.2 dB

CONFigure:RF:LEVel <numeric value>

RF output level of the test set

Syntax:	`CONFigure:RF:LEVel <numeric value>`		
Value Range:	-95 to –35	sets test set RF output [dBm]	Default Value: `–60 dBm`
Applicable in State:	Set: All Query: All		
Description:	This command configures the output power of the test set. When used in the RF Generator mode, (RFGE) it is necessary to wait approximately 200ms. before the new output level is valid. Also note that the value range depends on the setting of the RF attenuator switch. If the attenuator is set incorrectly, error code -221, "Settings Conflict" is returned RF attenuator switch bypass on: -75 to -35dBm RF attenuator switch bypass off: -95 to -55dBm		

Example:	`CONF:RF:LEV -60`	Sets RF level to –60 dBm

CONF:RFGEnerator:DEMOD <mode>

RF Demodulator Mode

Syntax:	`CONF:RFGEnerator:DEMOD <mode>`		
Value Range:	`CW`	CW mode	Default Value:
	BURST	Demodulation looks for Bluetooth burst	`CW`
Applicable in State:	Set: All		
	Query: All		
Description:	This command specifies the demodulation mode. When CW is selected, simple Freq.Offset, NTP and Deviation measurements can be made. No synchronization to the signal is attempted.		
	When Burst is selected, the standard test mode measurement can be made. (Frequency Offset, Delta F1, Delta F2, Freq.Drift) These measurements attempt to lock to the applied bluetooth signal by searching for the power envelope and the P0 Bit.		
	The various measurements use the normal parameters used for test mode (for example, packet length).		
	See also the command: CONF:RFGE:DEMOD:THRESH.		
Example:	`CONF:RFGE:DEMOD BURST`		Sets Burst Mode

CONF:RFGEnerator:DEMOD:THRESH <value>

RF Demodulator Power Threshold

Syntax:	`CONF:RFGEnerator:DEMOD:THRESH <value>`		
Value Range:	`-100 to 100`	Threshold value for the power envelope of the bluetooth burst [dBm].	Default Value: `Auto`
	AUTO	Automatic search for max peak.	
Applicable in State:	Set: All Query: All		
Description:	This command specifies the threshold value for the power envelope of the bluetooth burst when using the 'burst' demodulator mode. Hence this is the value used when the measurement attempts to find the power envelope of the applied bluetooth signal. See also the command: CONF:RFGE:DEMOD:THRESH.		
Example:	`CONF:RFGE:DEMOD:THRESH 20`		Sets 20 dBm threshold value

CONFigure:RFGEnerator:MODulation <value>

Modulation Scheme for RF Generator

Syntax:	`CONFigure:RFGEnerator:MODulation <value>`		
Value Range:	`BS33`	Bit sequence 00110011 (=33 hex)	Default Value: `CW`
	`BS55`	Bit sequence 01010101 (=55 hex)	
	`BS0F`	Bit sequence 00001111 (=0F hex)	
	`BURST`	Special test burst	
	`CW`	Constant Wave (no modulation)	
	`DH1_BS55`	DH1 packet with payload BS55	
	`DH1_BS33`	DH1 packet with payload BS33	
	`DH1_BS0F`	DH1 packet with payload BS0F	
Applicable in State:	Set: All Query: All		
Description:	This command configures the type of modulation used in RF Generator mode.		
Example:	`"CONF:RFGE:MOD CW"`		Sets CW Modulation

CONF:RFGEnerator:TUNE <value>

RF Generator Tuning Frequency

Syntax:	`CONF:RFGEnerator:TUNE <value>`		
Value Range:	`-3`	Offset = –300KHz	Default Value:
	`-2`	Offset = –200KHz	`0`
	`-1`	Offset = –100KHz	
	`0`	Offset = 0KHz	
	`1`	Offset = 100KHz	
	`2`	Offset = 200KHz	
	`3`	Offset = 300KHz	
Applicable in State:	Set: All Query: Not Applicable		
Description:	This command enables fine tuning of the RF Generator frequency, with the specified offset. Only used for special purposes.		
Example:	`CONF:RFGE:TUNE –2`		Sets a –200 kHz offset

CONFigure:SLAVe:BDADdr <value>

Slave Bluetooth Device Address (DUT)

Syntax:	`CONFigure:SLAVe:BDADdr <value>`	
Value Range:	12 digits in hex format	Default Value: `000000000020`
Applicable in State:	Set: All except CONN, and TCONN Query: All	
Description:	This command configures the DUT address in the test set	
Example:	`CONF:SLAV:BDAD AFC2DE56312F`	Sets address

CONFigure:TESTmode:MODE <value>

Testmode Mode selection

Syntax:	`CONFigure:TESTmode:MODE <value>`		
Value Range:	`LOOPback`	Loopback test mode	Default Value:
	`TRANsmit`	Transmitter test mode	`TRAN`
Applicable in State:	Set: All Query: All		
Description:	This command configures either transmitter or loopback test mode operation of the test set and DUT.		
Example:	`CONF:TEST:MODE LOOP`		Sets loopback test mode

CONFigure:TESTmode:TYPE <value>

Enable counter or Bluetooth testing

Syntax:	`CONFigure:TESTmode:TYPE <value>`		
Value Range:	`COUNT`	Enable Counter	Default Value:
	`BT`	Bluetooth mode	`Idle`
	`IDLE`	Disabled	
	`RFGE`	RF generator	
	`TESTMODE`	Bluetooth Test mode	
Applicable in State:	Set: All Query: All		
Description:	This command configures the required testing mode.		
Example:	`CONF:TEST:TYPE BT`		Sets Normal Mode

CONFigure:TESTmode:WAIT <setting>

Testmode - wait in Setup

Syntax:	`CONFigure:TESTmode:WAIT <setting>`		
Value Range:	`ON`	Wait enabled	Default Value:
	`OFF`	Wait disabled	`OFF`
Applicable in State:	Set: All Query: All		
Description:	This command sets the test set to wait in test mode before sending the test activate message to the DUT. This is required by some DUTs. With wait enabled the test set makes a normal connection to the DUT when PROC:TCONN:SET is sent but waits for the PROC:TCONN:CONT message. When this is sent the test set sends the test activate message and the test control message to the DUT		
Example:	`CONF:TEST:WAIT ON`		Sets Wait On

FETCH Subsystem

FETCH:BER?

Query Bit Error Rate continuously

Syntax:	FETCH:BER?		
Value Range:	<value>	Number of bits transferred	Default Value: Not Applicable
	<value>	Number of erroneous bits detected	
	<value>	BER [%]	
Applicable in State:	Query: TCONN		
Description:	This query is used to continuously measure the Bit Error values of the DUT. The data is returned prior to the completion of the measurement and so is only an indication of the BER. Use the READ:BER? command for the Bluetooth compliant measurement. Note that this is only applicable in loopback test mode.		
Example:	FETCH:BER?		

FETCH:NACK?

Query NACK Count continuously (Packet Error Rate)

Syntax:	FETCH:NACK?		
Value Range:	<value>	Number of packets transmitted	Default Value: Not Applicable
	<value>	Number of erroneous packets detected	
	<value>	NACK count [%]	
Applicable in State:	Query: CONN, TCONN		
Description:	This query is used to continuously measure the Packet Error Rate values of the DUT. The data is returned prior to the completion of the measurement and so is only an indication of the BER. Use the READ:NACK? command for the true measurement.		
Example:	FETCH:NACK?		

PROCedure Subsystem

PROCedure:BER:START <numeric value>

Start Bit Error Rate measurement

Syntax:	`PROCedure:BER:START <numeric value>`		
Value Range:	1 to 1.6E6	Number of bits used for the BER measurement	Default Value: Not Applicable
Applicable in State:	Set: TCONN Query: Not Applicable		
Description:	This command is used to start the Bit Error Rate (BER) measurement of the DUT. This command erases all previous BER data and starts a new measurement. Hence this command should be used when a parameter is changed during a BER test. Note that this is only applicable when in Loopback mode.		
Example:	`PROC:BER:START 1000`		Sets a value of 1000 bits for the measurement.

PROCedure:CONNection:RELease

Release Normal Connection

Syntax:	`PROCedure:CONNection:RELease`		
Value Range:	Not applicable		Default Value: Not Applicable
Applicable in State:	Set: CONN Query: Not Applicable		
Description:	This command closes (releases) the connection with the DUT. If there is no connection established, error code -221, “Settings Conflict” is returned.		
Example:	`PROC:CONN:REL`		Closes the connection

PROCedure:CONNection:SETup

Setup Normal Connection

Syntax:	`PROCedure:CONNection:SETup`		
Value Range:	Not applicable	Check with STAT:DEV to confirm connection established	Default Value: Not Applicable
Applicable in State:	Set: BT Query: Not Applicable		
Description:	This command initiates a normal Bluetooth connection (Page) with the DUT. If a connection is already established, error code -221, "Settings Conflict" is returned.		
Example:	`PROC:CONN:SET`		Initiates a connection attempt

PROCedure:NACK:START <numeric value>

Start NACK Count (Packet Error Rate)

Syntax:	`PROCedure:NACK:START <numeric value>`		
Value Range:	1 to 1.6E6	Number of packets used for calculating the NACK count	Default Value: Not Applicable
Applicable in State:	Set: CONN, TCONN Query: Not Applicable		
Description:	This command is used to start an unacknowledged (NACK) count measurement. A NACK measurement can be used as an alternative to the BER measurement. The NACK measurement can be made in Normal mode, whereas you can only make a BER measurement in Testmode. All unacknowledged packets are counted and compared the total number of packets sent.		
Example:	`PROC:NACK:START 1000`		Sets a value of 1000 packets to be used for the NACK count

NOTE This command erases all previous NACK data and starts a new measurement. This command should hence be used when different parameters are configured during a NACK test.

PROCedure:POWer:SET <value>

DUT power level control

Syntax:	`PROCedure:POWer:SET <value>`		
Value Range:	`INCR`	Increase power one step	Default Value:
	`DECR`	Decrease power one step	Not Applicable
Applicable in State:	Set: CONN, TCONN		
	Query: Not Applicable		
Description:	This command is used to control the output power of the DUT. (This is only applicable if the DUT supports power control.)		
Example:	`PROC:POW:SET INCR`		Increments the DUT power level

PROCedure:TCONNection:CONTinue

Continue Testmode Connection

Syntax:	`PROCedure:TCONNection:CONTinue`		
Value Range:	Not applicable	Check with STAT:DEV if connection was established	Default Value: Not Applicable
Applicable in State:	Set: TACTIVATE		
	Query: Not Applicable		
Description:	This command continues the setup sequence for a Testmode connection to the DUT. (See also CONF:TEST:WAIT command on page 97.)		
Example:	`PROC:TCONN:CONT`		Connection setup continues

PROCedure:TCONNection:RELease

Release the Bluetooth test mode connection

Syntax:	PROCedure:TCONNection:RELease	
Value Range:	Not applicable	Default Value: Not Applicable
Applicable in State:	Set: TCONN, TACTIVATE, TCONTROL Query: Not Applicable	
Description:	This command closes a Testmode connection with DUT. If there is no connection established, error code -221, "Settings Conflict" is returned.	
Example:	PROC:TCONN:REL	Releases the connection

PROCedure:TCONNection:SETup

Setup a Bluetooth test mode connection

Syntax:	PROCedure:TCONNection:SETup		
Value Range:	Not applicable	Check with STAT:DEV if connection is made	Default Value: Not Applicable
Applicable in State:	Set: TESTMODE Query: Not Applicable		
Description:	This command initiates a Testmode connection with DUT. If there is a connection already established, error code -221, "Settings Conflict" is returned.		
Example:	PROC:TCONN:SET		Opens the connection

NOTE The test set checks all relevant test mode settings prior to the setup. If the settings are inconsistent, the ErrorCode is set to -221: 'Settings conflict'.

READ Subsystem

READ:BER?

Read back the Bit Error Rate

Syntax:	READ:BER?		
Value Range:	<value>	BER [%] "NAN" is returned when the measurement is incomplete	Default Value: Not Applicable
Applicable in State:	Query: TCONN		
Description:	This query is used to measure the Bit Error Rate (BER) of the DUT. The measurement is calculated using the specified quantity of bits. The BER measurement may take a long time, depending on the number of bits used (set by the PROC:BER:START command). Therefore your application must poll the test set for a measurement result. When the response is different from Not A Number (NAN), the required number of bits has been transmitted and the measurement is complete.Use the FETCH:BER command if a continuous response is required. Note that this is only applicable in Loopback mode.		
Example:	READ:BER?		

READ:DELTA_F1?

Query Delta F1 Average (Modulation Characteristics)

Syntax:	READ:DELTA_F1?		
Value Range:	<value>	Deviation [kHz]	Default Value: Not Applicable
Applicable in State:	Query: TCONN, RFGE		
Description:	This query measures the Delta F1 average value of the DUT according to the RF test specifications (Bluetooth Test specification ver. 0.9, chap. 5.1.9). Initial conditions for this command are: Hopping is off Modulation must be BS0F		
Example:	READ:DELTA_F1?		

READ:DELTA_F2?

Query Delta F2 Average (Modulation Characteristics)

Syntax:	READ:DELTA_F2?		
Value Range:	<value>	Deviation [kHz]	Default Value: Not Applicable
Applicable in State:	Query: TCONN, RFGE		
Description:	This query measures the Delta F2 average value of the DUT according to the RF test specifications (Bluetooth Test specification ver. 0.9, chap. 5.1.9). Initial conditions for this command are: Hopping is off Modulation must be BS55 Packet length must be >2		
Example:	READ:DELTA_F2?		

READ:DELTA_F1_HIgh?

Query Delta F1 Max High (Modulation Characteristics)

Syntax:	READ:DELTA_F1_HIgh?		
Value Range:	<value>	Deviation [kHz]	Default Value: Not Applicable
Applicable in State:	Query: TCONN, RFGE		
Description:	This query measures the highest Delta F1 value of the current Delta F1 measurement. Note: READ:DELTA_F1? must be issued prior to this query		
Example:	READ:DELTA_F1_HI?		

READ:DELTA_F1_LOw?

Query Delta F1 Max Low (Modulation Characteristics)

Syntax:	READ:DELTA_F1_LOw?		
Value Range:	<value>	Deviation [kHz]	Default Value: Not Applicable
Applicable in State:	Query: TCONN, RFGE		
Description:	This query measures the lowest Delta F1 value of the current Delta F1 measurement. Note: READ:DELTA_F1? must be issued prior to this query		
Example:	READ:DELTA_F1_LO?		

READ:DELTA_F2_HIgh?

Query Delta F2 Max High (Modulation Characteristics)

Syntax:	READ:DELTA_F2_HIgh?		
Value Range:	<value>	Deviation [kHz]	Default Value: Not Applicable
Applicable in State:	Query: TCONN, RFGE		
Description:	This query measures the highest Delta F2 value of the current Delta F2 measurement. Note: READ:DELTA_F2? must be issued prior to this query		
Example:	READ:DELTA_F2_HI?		

READ:DELTA_F2_LOw?

Query Delta F2 Max Low (Modulation Characteristics)

Syntax:	READ:DELTA_F2_LOw?		
Value Range:	<value>	Deviation [kHz]	Default Value: Not Applicable
Applicable in State:	Query: TCONN, RFGE		
Description:	This query measures the lowest Delta F2 value of the current Delta F2 measurement. Note: READ:DELTA_F2? must be issued prior to this query		
Example:	READ:DELTA_F2_LO?		

READ:DEViation?

Query frequency deviation of the DUT

Syntax:	READ:DEViation?		
Value Range:	<value>	Deviation [kHz]	Default Value: Not Applicable
Applicable in State:	Query: CONN, TCONN		
Description:	This query measures the frequency deviation of the DUT.		
Example:	READ:DEV?		

READ:FEATURES?

Query DUT Features

Syntax:	READ:FEATURES?		
Value Range:	<F0 F1 F2 F3 F4 F5 F6 F7>	8 feature bytes, byte 0 to byte 7.	Default Value: Not Applicable
Applicable in State:	Query: CONN, TCONN		
Description:	This command is used to read back the features of the DUT. Response: F0 F1 F2 F3 F4 F5 F6 F7 where F0 is byte 0.		

Byte 0 Bit	0: 3-slot packets
	1: 5-slot packets
	2: encryption
	3: slot offset
	4: timing accuracy
	5: switch
	6: hold mode
	7: sniff mode
Byte 1 Bit	0: park mode
	1: RSSI
	2: channel quality driven data rate
	3: SCO link
	4: HV2 packets
	5: HV3 packets
	6: ulaw log
	7: Alaw log
Byte 0 Bit	0: CVSD
	1: paging scheme
	2: power control
	3: transparent SCO data
	4: flow control lag (bit0)
	5: flow control lag (bit2)
	6: flow control lag (bit3)

Example:	READ:FEATURES?

READ:FREQuency_COUNT?

Query Frequency Count

Syntax:	READ:FREQuency_COUNT?		
Value Range:	<value>	Frequency [Hz]	Default Value: Not Applicable
Applicable in State:	Query: TCONN, RFGE		
Description:	This query is used to measure frequency of the signal applied to the frequency counter input connector (COUNT IN). This feature is in particular designed for easy measurement of the DUT crystal frequency.		
Example:	READ:FREQuency_COUNT?		

READ:FREQ:DRIFt?

Query Frequency Drift

Syntax:	READ:FREQ:DRIFt?		
Value Range:	<value>	Frequency drift [Hz/s]	Default Value: Not Applicable
Applicable in State:	Query: CONN, TCONN, RFGE		
Description:	This query is used to give an indication of the carrier frequency drift of the DUT. The measurement uses the Preamble and the Trailer part of the burst. This measurement can be used in normal mode. If you can operate the DUT in test mode, use the READ:FREQ:DRIF:SPEC command instead.		
Example:	READ:FREQ:DRIF?		

READ:FREQ:DRIFt:SPEC?

Query Frequency Drift Specification

Syntax:	READ:FREQ:DRIFt:SPEC?		
Value Range:	<value>	Frequency drift [Hz]	Default Value: Not Applicable
Applicable in State:	Query: TCONN, RFGE		
Description:	This query is used to measure the carrier frequency drift of the DUT according to the RF test specifications (Bluetooth Test specification ver. 0.9, chap.5.1.11). Initial conditions for this command are: PacketType must be DH1/DH3/DH5 Modulation must be BS55 Packet length must be > 2		
Example:	READ:FREQ:DRIF:SPEC?		

READ:FREQ:DRIFt:SPEC:RATE?

Query Frequency Drift Specification Rate

Syntax:	READ:FREQ:DRIFt:SPEC:RATE?		
Value Range:	<value>	Frequency drift [kHz/10µs]	Default Value: Not Applicable
Applicable in State:	Query: TCONN, RFGE		
Description:	This query is used to measure the carrier frequency drift rate of the DUT according to the RF test specifications (Bluetooth Test specification ver. 0.9, chap.5.1.11). Note: the READ:FREQ:DRIF:SPEC? query must be issued before this query.		
Example:	READ:FREQ:DRIF:SPEC:RATE?		

READ:FREQ:OFFSet?

Query Frequency Offset

Syntax:	READ:FREQ:OFFSet?		
Value Range:	<value>	Frequency offset [Hz]	Default Value: Not Applicable
Applicable in State:	Query: CONN, TCONN, RFGE		
Description:	This query is used to measure the DUT frequency offset.		
Example:	READ:FREQ:OFFS?		

READ:NACK?

Query NACK Count (Packet Error Rate)

Syntax:	READ:NACK?		
Value Range:	<value>	NACK [%] "NAN" is returned when the measurement is incomplete	Default Value: Not Applicable
Applicable in State:	Query: CONN, TCONN		
Description:	This query is used to measure the Packet Error Rate of the DUT. The NACK count measurement may take a long time, depending on the number of packets used (set by the PROC:NACK:START command). Therefore your application must poll the test set for a measurement result. When the response is different from Not A Number (NAN), the required number of packets has been transmitted and the measurement is complete. Use the FETCH:NACK command if a continuous response is required.		
Example:	READ:NACK?		

READ:NTP?

Query Normal Transmit Power (NTP)

Syntax:	READ:NTP?		
Value Range:	<value>	NTP [dBm]	Default Value: Not Applicable
Applicable in State:	Query: CONN, TCONN, RFGE		
Description:	This query is used to measure the Normally Transmitted Power (NTP), burst average power, of the DUT.		
Example:	READ:NTP?		

READ:NTP_CHAN? <chan no.>

Query Normally Transmitted Power (NTP) in a specific channel

Syntax:	READ:NTP_CHAN? <chan no.>		
Value Range:	<chan no.> <value>	Channel no. (0 to 78) NTP for channel no. [dBm]	Default Value: Not Applicable
Applicable in State:	Query: CONN, TCONN, RFGE		
Description:	This query is used to measure the Normally Transmitted Power (NTP), average power, of the DUT for a specified channel. The test set replies with the most recent NTP value for the specified channel If the NTP for this channel has not been previously measured NAN is returned.		
Example:	READ:NTP_CHAN? 40		

READ:PSEUDO:DELTA_F1?

Query Pseudo Delta F1 Average

Syntax:	READ:PSEUDO:DELTA_F1?		
Value Range:	<value>	Deviation [kHz]	Default Value: Not Applicable
Applicable in State:	Query: TCONN, RFGE		
Description:	This command initiates a pseudo delta F1 average measurement of the DUT. This is achieved by searching for 111/000 patterns in the access code part of the burst and using these to give an indication of the Delta F1 value. However, unlike the Bluetooth compliant DELTA_F1? measurement, the PSEUDO:DELTA_F1? can be used with a normal connection		
Example:	READ:PSEUDO:DELTA_F1?		

READ:PSEUDO:DELTA_F2?

Query Pseudo Delta F2 Average

Syntax:	READ:PSEUDO:DELTA_F2?		
Value Range:	<value>	Deviation [kHz]	Default Value: Not Applicable
Applicable in State:	Query: TCONN, RFGE		
Description:	This command initiates a pseudo delta F2 average measurement of the DUT. This is achieved by searching for 101/010 patterns in the access code part of the burst and using these to give an indication of the Delta F2 value. However, unlike the Bluetooth compliant DELTA_F2? measurement, the PSEUDO:DELTA_F2? can be used with a normal connection		
Example:	READ:PSEUDO:DELTA_F2?		

READ:PTP?

Query Peak Transmit Power (PTP)

Syntax:	READ:PTP?		
Value Range:	<value>	PTP [dBm]	Default Value: Not Applicable
Applicable in State:	Query: CONN, TCONN, RFGE		
Description:	This query is used to measure the Peak Transmitted Power (PTP) power of the DUT.		
Example:	READ:PTP?		

STATus Subsystem

STATus:DEVice?

Query Device Status

Syntax:	STATus:DEVice?	
Value Range:	IDLE RFGE BT TESTMODE CONN TCONN	Default Value: Not Applicable
Applicable in State:	Query: ALL	
Description:	This query returns the test set state .	
Example:	STAT:DEV?	

SYSTem Subsystem

SYSTem:BT:VERS <version>

Set Bluetooth Version in the test set

Syntax:	SYSTem:BT:VERS<version>		
Value Range:	1.0 B 1.1	1.0 B version 1.1 version	Default Value: Not Applicable
Applicable in State:	Set: All Query: All		
Description:	This command sets Bluetooth version 1.0 B or 1.1 within the test set. You should send a SYST:WARM_START command before proceeding. This command is unaffected by the SYSTem:RESet command.		
Example:	SYST:BT:VERS 1.0B		Sets Bluetooth standard 1.0B in the test set.

SYSTem:COMMunication:PORT <value>

Set System Communication Port

Syntax:	SYSTem:COMMunication:PORT <value>		
Value Range:	LPT1 LPT2 LPT3		Default Value: LPT1
Applicable in State:	Set: ALL		
Description:	This command specifies the parallel port to be used by the test set		
Example:	SYST:COMM:PORT LPT2		Sets the port to LPT2

SYSTem:ERRor?

Query Last Error

Syntax:	SYSTem:ERRor?	
Value Range:	<error code> +0 No Error -102 Syntax Error -221 Settings Conflict -222 Data out of Range -224 Parameter Not Allowed -365 Time out Error -366 Target Error -420 Query Unterminated	Default Value: Not Applicable
Applicable in State:	Query: ALL	
Description:	This query returns the error status of the last command issued and clears the error.	
Example:	SYST:ERR?	

SYSTem:FIRMware:VERSion?

Query Firmware Version

Syntax:	SYSTem:FIRMware:VERSion?	
Value Range:	string containing firmware information	Default Value: Not Applicable
Applicable in State:	Query: ALL	
Description:	This query returns the version of the test set Firmware.	
Example:	SYST:FIRM:VERS?	

SYSTem:PCdriver:VERSion?

Query PC-driver Software Version

Syntax:	SYSTem:PCdriver:VERSion?	
Value Range:	String containing PC driver software information	Default Value: Not Applicable
Applicable in State:	Query: ALL	
Description:	This query returns the version of the test set PC-driver.	
Example:	SYST:PC:VERS?	

SYSTem:RESet

System Reset

Syntax:	SYSTem:RESet	
Value Range:	Not Applicable	Default Value: Not Applicable
Applicable in State:	Set: ALL Query: Not Applicable	
Description:	This command is used to reset the settings of the test set and requires 1-2 seconds to complete. Poll the status by issuing the SYSTem:STAT:DEV? command. Until the reset procedure is finished, the returned value is “OFF”. When finished the returned value is “IDLE”. The SYSTem:BT:VERS command is unaffected by the SYSTem:RESet command. See also SYST:WARM_START.	
Example:	SYST:RES	

SYSTem:TEST:ADC_BUF?

Self test of ADC Buffer

Syntax:	SYSTem:TEST:ADC_BUF?		
Value Range:	OK Error, xx	Test is OK Test failed. xx is the number of errors detected	Default Value: Not Applicable
Applicable in State:	Query: IDLE		
Description:	This selftest command tests that the PC is able to access the ADC buffer of the test set.		
Example:	SYST:TEST:ADC_BUF?		

SYSTem:TEST:COMM_BUF?

Self test of Communication Buffer

Syntax:	SYSTem:TEST:COMM_BUF?		
Value Range:	OK Error, xx	Test is OK Test failed. xx is the number of errors detected	Default Value: Not Applicable
Applicable in State:	IDLE		
Description:	This selftest command tests that the PC is able to access the communication buffer of the test set.		
Example:	SYST:TEST:COMM_BUF?		

SYSTem:TEST:DEViation?

Self test of Deviation

Syntax:	SYSTem:TEST:DEViation?		
Value Range:	OK Error, xx	Test is OK Test failed. xx is the measured deviation	Default Value: Not Applicable
Applicable in State:	IDLE		
Description:	This selftest command checks the test set is able to both modulate and demodulate the RF carrier. Note: ensure no signals are applied at the RF connector. (if possible remove connections to the RF connector during the test) .		
Example:	SYST:TEST:DEV?		

SYSTem:TEST:PoWeR?

Self test of Power

Syntax:	SYSTem:TEST:PoWeR?		
Value Range:	OK Error, xx	Test is OK Test failed. xx is the measured NTP	Default Value: Not Applicable
Applicable in State:	IDLE		
Description:	This selftest command checks the test set is able to both transmit power and measure power. Note: ensure no signals are applied at the RF connector. (if possible remove connections to the RF connector during the test) .		
Example:	SYST:TEST:PWR?		

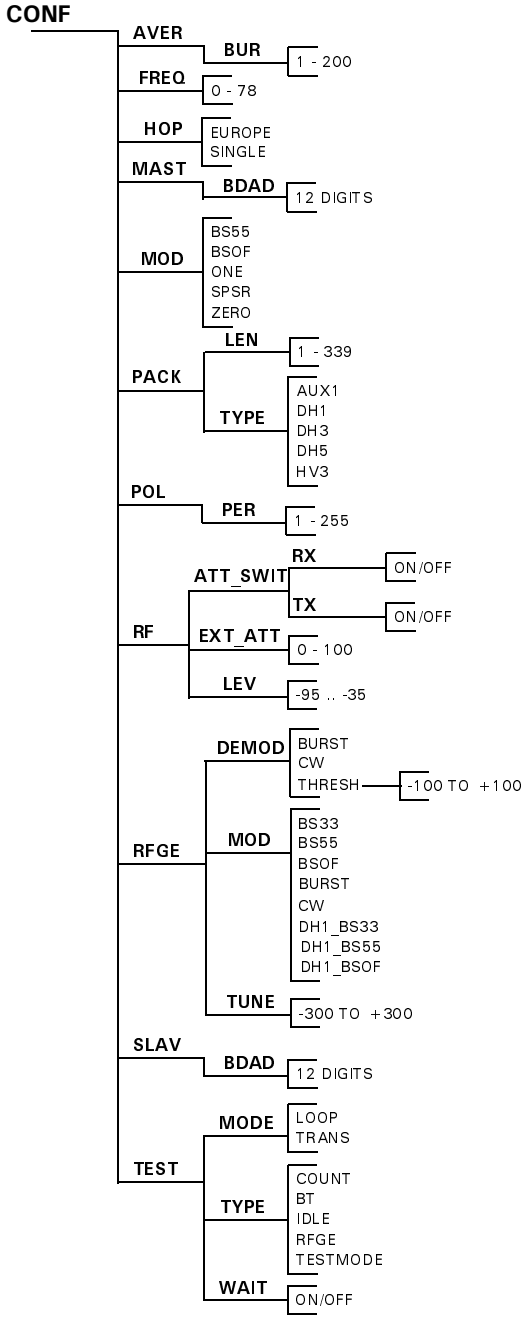
SYSTem:WARM_START

System Warm Start

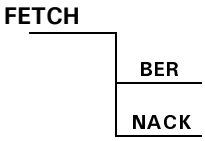
Syntax:	SYSTem:WARM_START	
Value Range:	Not Applicable	Default Value: Not Applicable
Applicable in State:	Set: All Query: Not Applicable	
Description:	This command is used to completely reset the test set. Using this command is similar to cycling the power and requires approximately 10 seconds to complete. Poll the status of the test set by issuing the STAT:DEV? command. When the WARM_START is complete the returned value changes from OFF to IDLE.	
Example:	SYST:WARM_START	

Command Structure

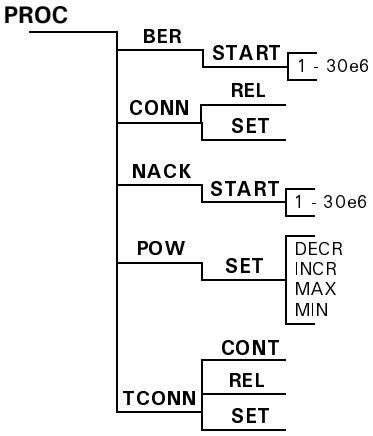
CONFigure



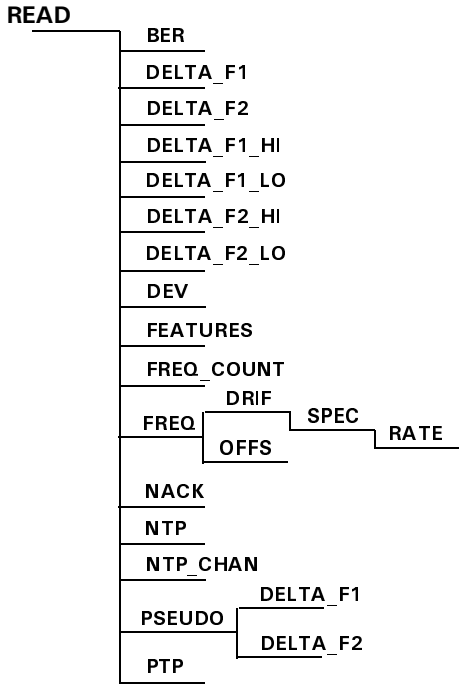
FETCH



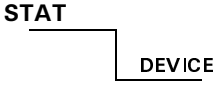
PROCedure



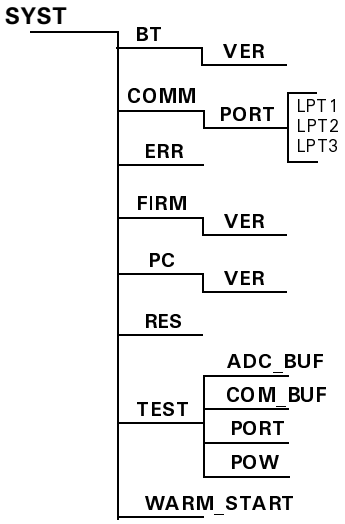
READ


READ
BER
DELTA_F1
DELTA_F2
DELTA_F1_HI
DELTA_F1_LO
DELTA_F2_HI
DELTA_F2_LO
DEV
FEATURES
FREQ_COUNT
FREQ
DRIF
SPEC
RATE
OFFS
NACK
NTP
NTP_CHAN
PSEUDO
DELTA_F1
DELTA_F2
PTP

STATus

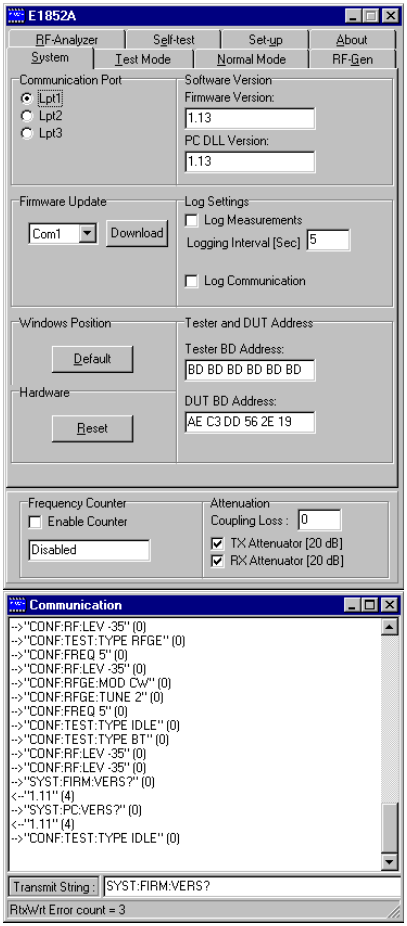

STAT
DEVICE

SYSTem


SYST
BT
VER
COMM
PORT
LPT1
LPT2
LPT3
ERR
FIRM
VER
PC
VER
RES
TEST
ADC_BUF
COM_BUF
PORT
POW
WARM_START

Sending Commands from the User Interface

The Windows user interface can be used as communication media for a SCPI command string. Starting in debug mode gives you access to a single line command field for testing and diagnostics. When starting in debug mode (**Start**, **Programs**, **Agilent Technologies**, **E1852A Debug**), a communication window appears below the main program.
The communication window contains an area showing the commands between the PC and the Test set, and a single-line command field.



At the start of the commands showed in the communication area is a arrow showing the direction of the command e.g. an arrow pointing to the right - -> is communication from the PC and an arrow pointing to the left <- - is reply from the Test set.

System error codes

Error Code	Error
+0	No Error
-102	Syntax Error
-221	Settings Conflict
-222	Data out of Range
-224	Parameter Not Allowed
-365	Time Out Error
-366	Target Error
-420	Query Unterminated

Switching between the page tabs shows the commands for configuring the system.

You can enter commands in the single line entry field. You can also capture the dialogue between your PC and test set when operating from the user interface. Saving this log file allows you to examine the commands and can help in the development of your own operating programs.

Example Program

Setup for Bluetooth RF measurements

The command setup for a Bluetooth measurement is shown in the following example:

Initial setup for measuring In Bluetooth Test mode (IDLE)

```
CONF:TEST:TYPE TESTMODE
CONF:FREQ 10
CONF:HOP SINGLE
CONF:TEST:MODE TRAN
CONF:PACK:LEN 27
CONF:PACK:TYPE DH1
CONF:MOD BS55
CONF:RF:LEV -35
CONF:POLL:PER 2
CONF:PACK:LEN 27
CONF:PACK:TYPE DH1
```

Paging the Bluetooth DUT Query status of the system (TESTMODE)

```
PROC:TCONN:SET
STAT:DEV?
```

Query Bluetooth RF measurements (TCONN)

```
READ:PTP?
READ:NTP?
```

6 Specifications and Characteristics

What You'll Find in This Chapter

This Chapter describes the Specifications and Characteristics of your E1852A Bluetooth Test Set.

It contains the following sections:

Introduction

This chapter details the specifications and supplemental characteristics of the E1852A Bluetooth Test Set.

Specifications - describe the warranted performance and apply after a 60 minute warm-up. These specifications are valid over the operating and environmental range of the test set unless otherwise stated.

Supplemental characteristics - *shown in italics*, are intended to provide information useful in applying the test set by giving typical (expected), but nonwarranted performance parameters. These characteristics are shown in italics or denoted as “typical”, “nominal” or “approximate”.

Functionality

Normal Mode

Ability to act as a Bluetooth Master, and establish a PAGED connection (Bluetooth Specification 1.1) with a Bluetooth device using a specified address.

Measurement Summary Screen	All Transmitter and Receiver measurements shown, with bar graphs using pass/fail limits. Link Status window.
Power Control	Instruct Device Under Test (DUT) to increase/decrease RF output power.
Payload	No payload is present in this mode.
Poll Period	1
Transmitter Measurements	Power and Frequency measurement results based on the use of a zero length payload. Graphical results showing: frequency versus time power versus time power versus channel number
Receiver Test	Packet Error Rate - Number of Not ACK Bursts settable and percentage reported.

Test Mode

Ability to set a Bluetooth Device in Bluetooth Test Mode [1.1] with the following control:

RF Channel	Enabling/disabling frequency hopping.
Poll Period:	1-255
Packet Types	DH1 DH3 DH5 HV3 AUX1
Packet Length	Variable, according to Bluetooth specifications for each packet type supported

Packet Payload	00000000 11111111 01010101 00001111 Pseudo-random (PN9)
DUT Mode	Transmitter Mode Loopback Mode
Results Averaging	1 to 200
Power Control	Instruct Device Under Control (DUT) to increase/decrease RF output power
Transmitter Measurements	Provide the following results: Average Power Peak Power Frequency Offset Frequency Drift Frequency Drift Rate Frequency Deviation (0F) calibrated Graphical Results showing: frequency versus time power versus time power versus channel number
Receiver Test	Number of test bits settable, up to 1.6 million BER count % reported

RF-Generator Burst or continuous signal on any channel, with selectable power output and frequency offset. 01010101, 00110011 and 00001111 payloads supported.

RF-Analyzer Transmitter measurements as described in Test Mode, but for use when no link is established (DH1, DH3 or DH5 packets and 01010101, 00110011 or 00001111 payloads only).

Performance

The test set will meet its specifications after 2 hours of storage within the operating temperature range, 60 minutes after turn on.

RF Generator

Frequency:	
Range	2402 MHz - 2480 MHz, 79 channels at 1 MHz spacing
Modulation	Conforms to Bluetooth Radio Specification 1.1
Offset	±300 kHz in 100 kHz increments
Power:	
Range	–95 dBm to –35 dBm
Resolution	0.1 dB
Accuracy[1] at -70 dBm	±0.9 dB at 25°C ±3°C, ±1.4 dB over full operating temperature
Accuracy[1] at 2442 MHz over the output range -85 to -35 dBm	±1.4 dB at 25°C ±3°C, ±1.9 dB over full operating temperature

RF Analyzer

Frequency:	
Range	2402 MHz - 2480 MHz, 79 channels at 1 MHz spacing
Demodulation	±400 kHz maximum
Error	*±(Timebase error +5 kHz) (nominal)*
Power:	
Range	–55 dBm to +23 dBm
Resolution	0.1 dB
Measurement[2] accuracy at 0 dBm	±0.7 dB at 25°C ±3°C, ±1.3 dB over full operating temperature

[1] A measurement uncertainty of 0.4 dB is included in these limits.

[2] A measurement uncertainty of 0.35 dB is included in these limits.

	Measurement[2] at 2442 MHz over the output range -30 to +22 dBm	±0.9 dB at 25°C ±3°C, ±1.3 dB over full operating temperature
Frequency Counter Input	**Range**	10 kHz to 15 MHz
	Frequency Error	*±(Timebase error +5 kHz) (nominal)*
	Resolution	1 Hz
	Sensitivity	*0.5V RMS (nominal)*
Frequency Reference	**Internal:** **Drift due to temperature**	±2.0 ppm
	Ageing	±1.0 ppm per year
	Frequency Reference Input: **Frequency**	*10 MHz (nominal)*
	Sensitivity	*150 mV into 50Ω (nominal)*

[2] A measurement uncertainty of 0.35 dB is included in these limits.

These uncertainty values are calculated using ISO TAG4, in line with the 'Guide to the Expression of Uncertainty in Measurement' and are based on a standard uncertainty multiplied by a coverage factor of k = 2, providing a confidence level of approximately 95%

General Specifications

Input /Output Connectors

- RF In/Out N(f), *50Ω (nominal)*
- Counter In BNC(f), high impedance
- Parallel Port 25-pin D-sub (m)
- Serial Port [RS-232] 9-pin D-sub(f) used for firmware downloads
- Frequency Reference Input, BNC (f) *50Ω (nominal)*
- Analog Outputs, BNC(f), *50Ω (nominal)*
  - Bluetooth Slot Clock (625µs interval)
  - Received Data
  - Receive Slot Sync, output synchronized to start of burst
  - Power Envelope

Environmental Conditions

Operating Temperature	+15°C to +45°C
Operating Humidity	Up to 95% relative humidity to 40°C (non-condensing)

Power Consumption

Supply Voltage	100-120VAC, 200-240VAC 50-60 Hz 30 VA maximum

Physical

Dimensions	92mm (H) x 280 mm (D) x 484 mm (W) Designed for rack mounting
Weight	3.5 kg

Computer Requirements

The test set requires the use of a PC (not supplied), minimum requirements as follows:

- Pentium® Processor or higher, 32MB RAM or more, 200MB available on hard drive
- Windows® 95, Windows® 98, Windows 2000®, Windows NT® 4.0 (SP 3)
- Dedicated bi-directional parallel port
- 1024 x 768 color monitor resolution
- Microsoft Internet Explorer version 4.0 or higher/ Netscape Communicator Version 4.0 or higher required for software/firmware upgrades.

Regulatory Information

All regulatory information is contained in the E1852A Bluetooth Test Set *Installation Guide*.

7 Maintenance

What You'll Find in This Chapter

This chapter describes the built in tests, error messages, and general maintenance. It contains these sections:

Self Test

The test set has two self test modes:

- Power on self test - occurs automatically when you turn on the test set.
- Self-Test - a series of tests you can carry out as required using the windows interface or remote commands.

Power On Test

The power on self test is performed automatically when the test set is turned on and takes approximately 5 seconds to complete. As the power on self test takes place, all the front panel LEDs are lit. When completed, only the Power LED remains lit.

Self Test

You can carry out a self test from the windows interface or by using remote commands.

Windows Interface

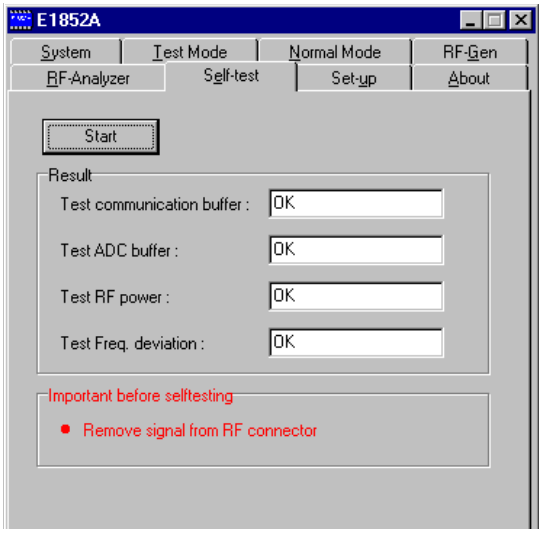


Figure 52 Self-test page

Ensure there is no connection made to the RF In/Out port and click **Start** to begin the self test. Refer to Self-test Page on page 50 for more information.

Remote Interface

To invoke the remote self tests, use the following commands:

- `SYST:TEST:COMM_BUF?`
- `SYST:TEST:ADC_BUF?`
- `SYST:TEST:PWR?`
- `SYST:TEST:DEV?`

LED Indicators

There are 7 LED indicators on the front panel of the E1852A Bluetooth Test Set. Table 7 shows the behavior of the LED indicators according to the mode of the test set. The Error LED is turned on if the last SCPI command issued was wrong. The Error LED is turned off again as soon as a correct SCPI command is received.

Table 7 LED Indicators and Test Set Mode

Measurement Mode	Power	Error	Transmit	Loopback	Master	Slave	Link
Off							
Initializing	ON	ON	ON	ON	ON	ON	ON
Idle Mode	ON	ON[1]					
RF-generator Mode	ON	ON[1]			ON	ON	
Demodulator Mode	ON	ON[1]			ON	ON	
Normal Mode - Master	ON	ON[1]			ON		ON[2]
Normal Mode – Slave	ON	ON[1]				ON	ON[2]
Transmitter Test Mode	ON	ON[1]	ON		ON		ON[2]
Loopback Test Mode	ON	ON[1]		ON	ON		ON[2]

[1] If wrong SCPI commands is being used

[2] Only if Connection is established

Operator Maintenance

This section describes how to install new revisions of test set firmware. It also shows you how to replace the power line fuse and clean the test set.

Firmware Download

The windows interface and test set firmware revisions are matched. To install new test set firmware you must first install the new revision of windows interface software. To download new firmware the test set serial port and the supplied serial cable are used. You also need to run the windows interface in Debug mode.

Updated windows interface software and test set firmware can be obtained from the URL shown in the **About** page of the E1852A windows interface. Use this URL to access the E1852A Software home page and follow the displayed instructions to download and install the required files.

Replacing the Power Line Fuse

The power line fuse is located within the fuse holder and line switch assembly on the rear panel. For 110V to 120V operation the fuse is a T0.25 250V, for 220-240V operation the fuse is a T0.125 250V.

1 Remove the power cord from the test set.

2 Install the correct fuse in the “selected” position as shown in Figure 53.

3 Replace the fuse holder assembly in the rear panel.

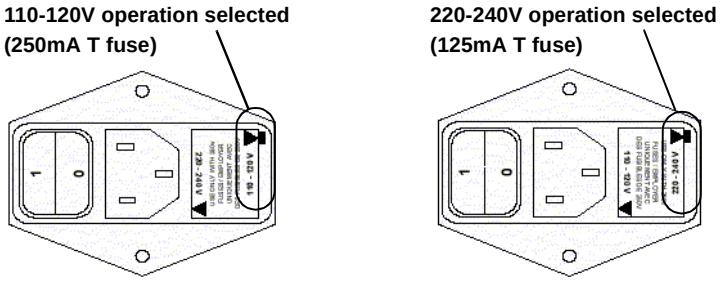


Figure 53 Replacing the Fuse

Cleaning

To clean the test set, disconnect it’s supply power and wipe with a damp cloth only.

Contacting Agilent Technologies

This section details what to do if you have a problem with your test set.

If you have a problem with your test set, first refer to the section. This chapter contains a checklist that will help identify some of the most common problems.

If you wish to contact Agilent Technologies about any aspect of the test set, from service problems to ordering information, refer to see Sales and Service Offices on page 148.

If you wish to return the test set to Agilent Technologies refer to see Returning Your Bluetooth Test Set for Service on page 149.

Before calling Agilent Technologies

Before calling Agilent Technologies or returning the test set for service, please make the checks listed in see Check the Basics on page 145. If you still have a problem, please read the warranty printed at the front of this guide. If your test set is covered by a separate maintenance agreement, please be familiar with the terms.

Agilent Technologies offers several maintenance plans to service your test set after warranty expiration. Call your Agilent Technologies Sales and Service Center for full details.

If the test set becomes faulty and you wish to return the faulty instrument, follow the description on how to return the faulty instrument in the section see Sales and Service Offices on page 148.

Check the Basics

Problems can be solved by repeating what was being performed when the problem occurred. A few minutes spent in performing these simple checks may eliminate time spent waiting for instrument repair. Before calling Agilent Technologies or returning the test set for service, please make the following checks:

- Check that the line socket has power.

- Check that the test set is plugged into the proper ac power source.
- Check that the test set is switched on.
- Check that the line fuse is in working condition.
- Check that the other equipment, cables, and connectors are connected properly and operating correctly.
- Check the equipment settings in the procedure that was being used when the problem occurred.
- Check that the test being performed and the expected results are within the specifications and capabilities of the test set.
- Check operation by performing the Self-test.

Instrument serial numbers

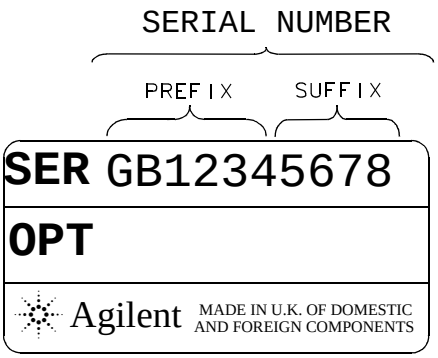
Agilent Technologies makes frequent improvements to its products to enhance their performance, usability and reliability. Agilent Technologies service personnel have access to complete records of design changes for each instrument. The information is based on the serial number and option designation of each test set.

Whenever you contact Agilent Technologies about your test set, have a complete serial number available. This ensures you obtain the most complete and accurate service information. The serial number can be obtained from the serial number label.

The serial number label is attached to the rear of each Agilent Technologies instrument. This label has two instrument identification entries. The first provides the instruments serial number and the second provides the identification number for each option built into the instrument.

The serial number is divided into two parts: the prefix (two letters and the first four numbers), and the suffix (the last four numbers).

- The prefix letters indicate the country of manufacture. This code is based on the ISO international country code standard, and is used to designate the specific country of manufacture for the individual product. The same product number could be manufactured in two different countries. In this case the individual product serial numbers would reflect different country of manufacture codes. The prefix also consists of four numbers. This is a code identifying the date of the last major design change.
- The suffix indicates an alpha numeric code which is used to ensure unique identification of each product throughout Agilent Technologies.



Sales and Service Offices

For more information about Agilent Technologies test and measurement products, applications, services, and for a current sales office listing, visit our web site: http://www.agilent.com

You can also contact one of the following centers and ask for a test and measurement sales representative.

UNITED STATES	Agilent Technologies (tel) 1 800 452 4844
CANADA	Agilent Technologies Canada Inc. Test & Measurement (tel) 1 877 894 4414
EUROPE	Agilent Technologies Test & Measurement European Marketing Organization (tel) (31 20) 547 2000
JAPAN	Agilent Technologies Japan Ltd. (tel) (81) 426 56 7832 (fax) (81) 426 56 7840
LATIN AMERICA	Agilent Technologies Latin America Region Headquarters, USA (tel) (305) 267 4245 (fax) (305) 267 4286
AUSTRALIA and NEW ZEALAND	Agilent Technologies Australia Pty Ltd. (tel) 1-800 629 4852 (Australia) (fax) (61 3) 9272 0749 (Australia) (tel) 0-800 738 378 (New Zealand) (fax) (64 4) 802 6881 (New Zealand)
ASIA PACIFIC	Agilent Technologies, Hong Kong (tel) (852) 3197 7777 (fax) (852) 2506 9284

In any correspondence or telephone conversations, refer to the power sensor by its model number and full serial number. With this information, the Agilent Technologies representative can quickly determine whether your unit is still within its warranty period.

Returning Your Bluetooth Test Set for Service

Use the information in this section if you need to return your test set to Agilent Technologies.

Package the Bluetooth Test Set For Shipment

Use the following steps to package the test set for shipment to Agilent Technologies for service:

1 Fill in a blue service tag (available at the end of the *Installation Guide*) and attach it to the test set. Please be as specific as possible about the nature of the problem. Send a copy of any or all of the following information:

- Any error messages generated by the test set.
- Any information on the performance of the test set.

CAUTION Damage can result from using packaging materials other than those specified. Never use styrene pellets in any shape as packaging materials. They do not adequately cushion the test set or prevent it from shifting in the carton. Styrene pellets cause damage by generating static electricity.

2 Use the original packaging materials or a strong shipping container that is made of double-walled, corrugated cardboard with 159 kg (350 lb) bursting strength. The carton must be both large enough and strong enough to accommodate the test set and allow at least 3 to 4 inches on all sides of the test set for packing material.

3 Surround the test set with at least 3 to 4 inches of packing material, or enough to prevent the test set from moving in the carton. If packing foam is not available, the best alternative is SD-240 Air Cap ™ from Sealed Air Corporation (Commerce, CA 90001). Air Cap looks like a plastic sheet covered with 1-1/4 inch air filled bubbles. Use the pink Air Cap to reduce static electricity. Wrap the test set several times in the material to both protect the test set and prevent it from moving in the carton.

4 Seal the shipping container securely with strong nylon adhesive tape.

5 Mark the shipping container “FRAGILE, HANDLE WITH CARE” to ensure careful handling.

6 Retain copies of all shipping papers.